Tektronix[®]

6 Series B MSO

Mixed Signal Oscilloscope Datasheet

More Bandwidth. More Channels. Less Noise.



Confidence in numbers

Input channels

- 4, 6, or 8 FlexChannel[®] inputs
- Each FlexChannel provides:
 - One analog signal that can be displayed as a waveform view, a spectral view, or both simultaneously
 - Eight digital logic inputs with TLP058 logic probe

Bandwidth (all analog channels)

• 1 GHz, 2.5 GHz, 4 GHz, 6 GHz, 8 GHz, 10 GHz (upgradable)

Sample rate (all analog / digital channels)

- Real-time: 50 GS/s (2 channels), 25 GS/s (4 channels), 12.5 GS/s (> 4 channels)
- Interpolated: 2.5 TS/s

Record length (all analog / digital channels)

- 62.5 Mpoints standard
- 125, 250, 500 Mpoints, or 1 Gpoints (optional)

Waveform capture rate

>500,000 waveforms/s

Vertical resolution

- 12-bit ADC
- Up to 16-bits in High Res mode

Standard trigger types

- Edge, Pulse Width, Runt, Timeout, Window, Logic, Setup & Hold, Rise/ Fall Time, Parallel Bus, Sequence, Visual Trigger, Video (optional), RF vs. Time (optional)
- Auxiliary Trigger ≤5 V_{RMS}, 50Ω, 400 MHz (Edge Trigger only)

Standard analysis

- Cursors: Waveform, V Bars, H Bars, V&H Bars
- Measurements: 36
- Spectrum View: Frequency-domain analysis with independent controls for frequency and time domains
- FastFrame[™]: Segmented memory acquisition mode with maximum trigger rate >5,000,000 waveforms per second
- Plots: Time Trend, Histogram, Spectrum and Phase Noise
- Math: Basic waveform arithmetic, FFT, and advanced equation editor
- Search: Search on any trigger criteria
- Jitter: TIE and Phase Noise

¹ Optional and upgradable.

2 Free with product registration.

Optional analysis

- Advanced Jitter and Eye Diagram Analysis
- Advanced Spectrum View
- RF vs. Time traces (magnitude, frequency, phase)
- Digital Power Management
- Mask/Limit Testing
- Inverters, Motors, and Drives
- LVDS Debug and Analysis
- PAM3 Analysis
- Advanced Power Measurements and Analysis

Optional serial bus trigger, decode and analysis

 I²C, SPI, I3C, RS-232/422/485/UART, SPMI, CAN, CAN FD, LIN, FlexRay, SENT, PSI5, Automotive Ethernet, MIPI D-PHY, USB 2.0, eUSB2, Ethernet, Audio, MIL-STD-1553, ARINC 429, Spacewire, 8B/ 10B, NRZ, Manchester, SVID, MDIO

Optional serial compliance test

• Ethernet, USB 2.0, Automotive Ethernet, Industrial Ethernet , MIPI D-PHY 1.2

Optional memory analysis

DDR3 debug, analysis, and compliance test

Arbitrary/Function Generator ¹

- 50 MHz waveform generation
- Waveform Types: Arbitrary, Sine, Square, Pulse, Ramp, Triangle, DC Level, Gaussian, Lorentz, Exponential Rise/Fall, Sin(x)/x, Random Noise, Haversine, Cardiac

Digital voltmeter²

4-digit AC RMS, DC, and DC+AC RMS voltage measurements

Trigger frequency counter ²

8-digit

Display

- 15.6-inch (396 mm) TFT color
- High Definition (1,920 x 1,080) resolution
- Capacitive (multi-touch) touchscreen

Connectivity

 USB Host (7 ports), USB 3.0 Device (1 port), LAN (10/100/1000 Base-T Ethernet), Display Port, DVI-I, VGA

e*Scope ®

• Remotely view and control the oscilloscope over a network connection through a standard web browser

Warranty

• 1 year standard

Dimensions

- 12.2 in (309 mm) H x 17.9 in (454 mm) W x 8.0 in (204 mm) D
- Weight: <28.4 lbs. (12.88 kg)

With the lowest input noise and up to 10 GHz analog bandwidth, the 6 Series MSO provides the best signal fidelity for analyzing and debugging today's embedded systems with GHz clock and bus speeds. The remarkably innovative pinch-swipe-zoom touchscreen user interface coupled with the industry's largest high definition display and up to 8 FlexChannel[®] inputs that let you measure one analog or eight digital signals per channel, the 6 Series MSO is ready for today's toughest challenges and tomorrow's too.

Never let a lack of channels slow down your verification and debug process again

The 6 Series MSO offers better visibility into complex systems by offering four, six and eight-channel models with a large 15.6-inch high-definition (1,920 x 1,080) display. Many applications, such as embedded systems, three-phase power electronics, automotive electronics, power supply design, and Power Integrity require the observation of more than four analog signals to verify and characterize device performance and to debug challenging system issues.

Most engineers can recall situations in which they were debugging a particularly difficult problem and wanted greater system visibility and context, but the oscilloscope they were using was limited to two or four analog channels. Using a second oscilloscope involves significant effort to align the trigger points, difficulty in determining the timing relationships across the two displays, and documentation challenges.

You might assume that a six and eight-channel oscilloscope would cost 50% or 100% more than a four-channel oscilloscope, you'll be pleasantly surprised to find that six-channel models are only \sim 25% more than four channel models and eight-channel models are only \sim 67% (or less) more than four channel models. The additional analog channels can pay for themselves quickly by enabling you to keep current and future projects on schedule.

$\ensuremath{\mathsf{FlexChannel}}\xspace^{\ensuremath{\mathsf{\$}}}$ technology enables maximum flexibility and broader system visibility

The 6 Series MSO redefines what a Mixed Signal Oscilloscope (MSO) should be. FlexChannel technology enables each channel input to be used as a single analog channel, eight digital logic inputs (with the TLP058 logic probe), or simultaneous analog and spectrum views with independent acquisition controls for each domain. Imagine the flexibility and configurability this provides.

You can change the configuration at any time by simply adding or removing TLP058 logic probes, so you always have the right number of digital channels.



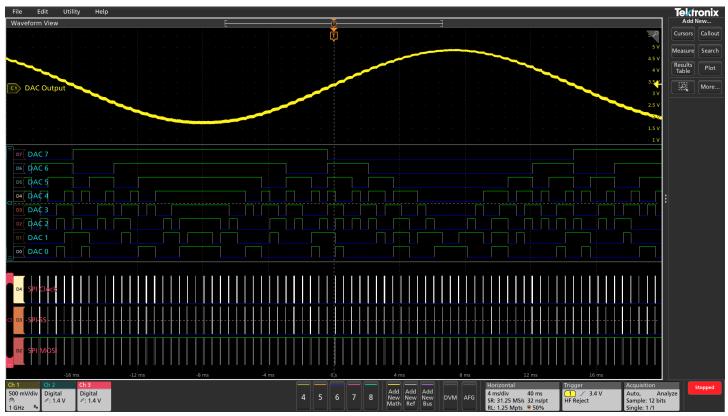
FlexChannel technology enables the ultimate in flexibility. Each input can be configured as a single analog or eight digital channels based on the type of probe you attach.

Previous-generation MSOs required tradeoffs, with digital channels having lower sample rates or shorter record lengths than analog channels. The 6 Series MSO offers a new level of integration of digital channels. Digital channels share the same high sample rate (up to 50 GS/s), and long record length (up to 1 Gpoints) as analog channels.



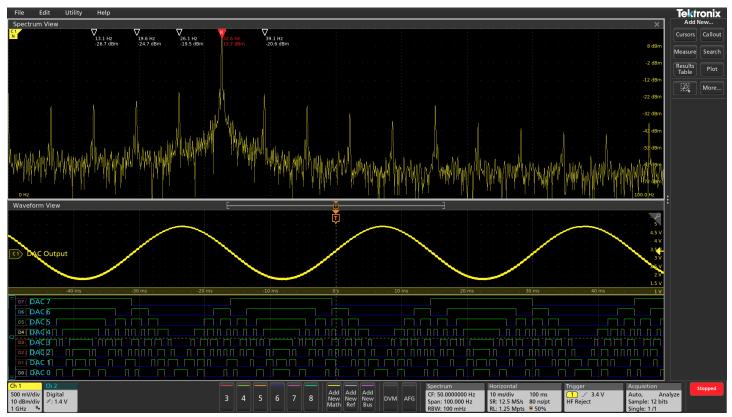
The TLP058 provides eight high performance digital inputs. Connect as many TLP058 probes as you like, enabling up to a maximum of 64 digital channels.

Datasheet



Channel 2 has a TLP058 Logic Probe connected to the eight inputs of a DAC. Notice the green and blue color coding, where ones are green and zeros are blue. Another TLP058 Logic Probe on Channel 3 is probing the SPI bus driving the DAC. The white edges indicate higher frequency information is available by either zooming in or moving to a faster sweep speed on the next acquisition.

6 Series B MSO

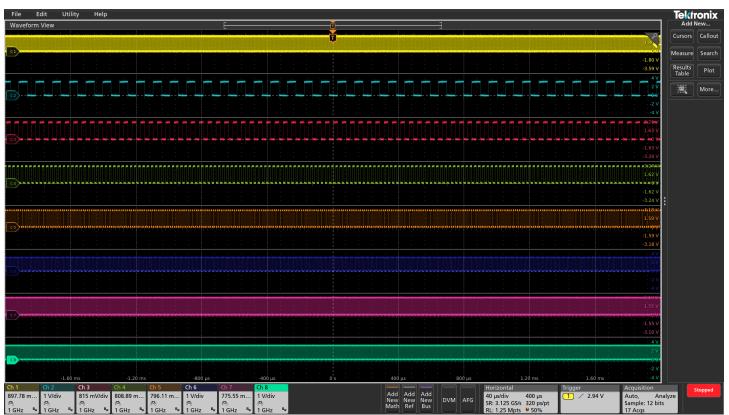


Beyond just analog and digital, FlexChannel inputs include Spectrum View. This Tektronix-patented technology enables you to simultaneously view both analog and spectral views of all your analog signals, with independent controls in each domain. For the first time ever, oscilloscope-based frequency-domain analysis is as easy as using a spectrum analyzer while retaining the ability to correlate frequency-domain activity with other time-domain phenomena.

Unprecedented signal viewing capability

The stunning 15.6" (396 mm) display in the 6 Series MSO is the largest display in the industry. It is also the highest resolution display, with full HD resolution (1,920 x 1,080), enabling you to see many signals at once with ample room for critical readouts and analysis.

The viewing area is optimized to ensure that the maximum vertical space is available for waveforms. The Results Bar on the right can be hidden, enabling the waveform view to use the full width of the display.



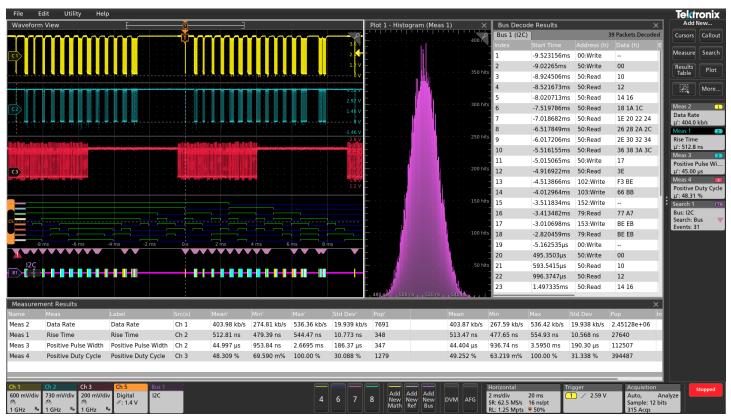
Stacked display mode enables easy visibility of all waveforms while maintaining maximum ADC resolution on each input for the most accurate measurements.

The 6 Series MSO offers a revolutionary new Stacked display mode. Historically, scopes have overlaid all waveforms in the same graticule, forcing difficult tradeoffs:

- To make each waveform visible, you vertically scale and position each waveform so that they don't overlap. Each waveform uses a small percentage of the available ADC range, leading to less accurate measurements.
- For measurement accuracy, you vertically scale and position each waveform to cover the entire display. The waveforms overlap each other, making it hard to distinguish signal details on individual waveforms

The new Stacked display eliminates this tradeoff. It automatically adds and removes additional horizontal waveform 'slices' (additional graticules) as waveforms are created and removed. Each slice represents the full ADC range for the waveform. All waveforms are visually separated from each other while still using the full ADC range, enabling maximum visibility and accuracy. And it's all done automatically as waveforms are added or removed! Channels can easily be reordered in stacked display mode by dragging and dropping the channel and waveform badges in the Settings bar at the bottom of the display. Groups of channels can also be overlaid within a slice to simplify visual comparison of signals.

The massive display in the 6 Series MSO also provides plenty of viewing area not only for signals, but also for plots, measurement results tables, bus decode tables and more. You can easily resize and relocate the various views to suit your application.



Viewing three analog channels, eight digital channels, a decoded serial bus waveform, decoded serial packet results table, four measurements, a measurement histogram, measurements results table with statistics and a search on serial bus events - simultaneously!

Exceptionally easy-to-use user interface lets you focus on the task at hand

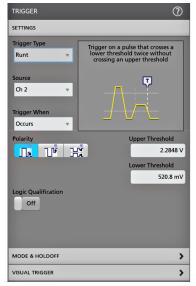
The Settings Bar - key parameters and waveform management

Waveform and scope operating parameters are displayed in a series of "badges" in the Settings Bar that runs along the bottom of the display. The Settings Bar provides Immediate access for the most common waveform management tasks. With a single tap, you can:

- Turn on channels
- Add math waveforms
- Add reference waveforms
- Add bus waveforms
- Enable the optional integrated Arbitrary/Function generator (AFG)
- Enable the optional integrated digital voltmeter (DVM)

The Results Bar - analysis and measurements

The Results Bar on the right side of the display includes immediate, onetap access to the most common analytical tools such as cursors, measurements, searches, measurement and bus decode results tables, plots, and callouts. DVM, measurement and search results badges are displayed in the Results Bar without sacrificing any waveform viewing area. For additional waveform viewing area, the Results Bar can be dismissed and brought back at any time.



Configuration menus are accessed by simply double-tapping on the item of interest on the display. In this case, the Trigger badge was double-tapped to open the Trigger configuration menu.

Touch interaction finally done right

Scopes have included touch screens for years, but the touch interface has been an afterthought. The 6 Series MSO's 15.6" display includes a capacitive touchscreen and provides the industry's first oscilloscope user interface truly designed for touch.

The touch interactions that you use with phones and tablets, and expect in a touch enabled device, are supported in the 6 Series MSO.

- Drag waveforms left/right or up/down to adjust horizontal and vertical position or to pan a zoomed view
- Pinch and expand to change scale or zoom in/out in either horizontal or vertical directions
- Flick items off the edge of the screen to delete them
- Swipe in from the right to reveal the Results Bar or down from the top to access the menus in the upper left corner of the display

Smooth, responsive front panel controls allow you to make adjustments with familiar knobs and buttons, and you can add a mouse or keyboard as a third interaction method.



Interact with the capacitive touch display in the same way you do on your phones and tablets.

Variable font size

Historically, oscilloscope user interfaces have been designed with fixed font sizes to optimize viewing of waveforms and readouts. This implementation is fine if all users have the same viewing preferences, but they don't. Users spend a significant amount of time staring at screens, and Tektronix recognizes this. The 6 Series MSO offers a user preference for variable font sizes; scaling down to 12 points or up to 20 points. As you adjust the font size, the user interface dynamically scales so you can easily choose the best size for your application.

12 POINT			-160 ns	0:5	160 ns			-400 mV -640 ms	
Ch 1 100 mV/div 1 MQ 500 MHz №				2	3 4 5 6 7	8 Add Add Add New New New New Math Ref Bus	DVM AFG Horizontal SR: 6.25 GS/s RL: 10 kpts	Trigger Acquisition 1.6 µs 1 ✓ 0 V Manual, 160 ps/pt \$	
DEFAULT -640 ns	-480 ns	-320 ns	-160 ns	0¦s	160 ns	320 ns	480 ns	640 ns	
Ch 1 100 mV/div 1 MΩ 500 MHz ^B *			2 3 4	5 6 7	8 Add Add Add New New Ref Bus	DVM AFG		Trigger Acquisition 1 ✓ 0 V Sample: 12 bits 0 Acqs	/ze
20 POINT	-480 ns	-320 ns	-160 ns		160 ns	320 ns	480 ns	-400 mV	
<mark>Ch 1</mark>	2 3 4	5 6 7	8 Add Ac New Ne Math Re	w New DVN	AFG AFG RL: 10 k	liv 1.6 µs GS/s 160 ps/pt	Trigger <mark>1</mark> ∕ 0 V	Acquisition Manual, Analyze Sample: 12 bits 0 Acqs	Preview

Comparison showing how the user interface scales as font size changes.



Efficient and intuitive front panel provides critical controls while still leaving room for the massive 15.6" high definition display.

Attention to detail in the front-panel controls

Traditionally, the front face of a scope has been roughly 50% display and 50% controls. The 6 Series MSO display fills about 85% of the face of the instrument. To achieve this, it has a streamlined front panel that retains critical controls for simple intuitive operation, but with a reduced number of menu buttons for functions directly accessed via objects on the display.

Color-coded LED light rings indicate trigger source and vertical scale/ position knob assignments. Large, dedicated Run/ Stop and Single Sequence buttons are placed prominently in the upper right, and other functions like Force Trigger, Trigger Slope, Trigger Mode, Default Setup, Auto-set and Quick-save functions are all available using dedicated front panel buttons.

Windows or not - you choose

The 6 Series MSO offers you the choice of whether to include a Microsoft Windows[™] operating system.

The 6 Series MSO comes with a standard removable SSD that contains a closed embedded operating system that will boot as a dedicated scope with no ability to run or install other programs. An optional SSD with Windows 10 operating system is available that will boot to an open Windows 10 configuration, so you can minimize the oscilloscope application and access a Windows desktop where you can install and run additional applications on the oscilloscope or you can connect additional monitors and extend your desktop. Simply swap the drives as needed through an access panel on the bottom of the instrument.

Whether you run Windows or not, the oscilloscope operates in exactly the same way with the same look and feel and UI interaction.

Need higher channel density?

The 6 Series is also available as a low-profile digitizer - the LPD64. With four SMA input channels plus an auxiliary trigger input, in a 2U high package and 12-bit ADC's, the 6 Series Low Profile Digitizer sets a new standard for performance in applications where extreme channel density is required.

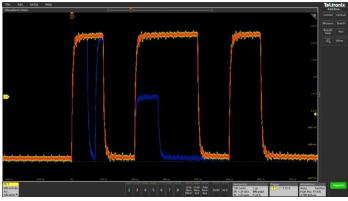


Experience the performance difference

With up to 10 GHz analog bandwidth, 50 GS/s sample rates, standard 62.5 Mpts record length and a 12-bit analog to digital converter (ADC), the 6 Series MSO has the performance you need to capture waveforms with the best possible signal fidelity and resolution for seeing small waveform details.

Digital Phosphor technology with FastAcq[™] highspeed waveform capture

To debug a design problem, first you must know it exists. Digital phosphor technology with FastAcq provides you with fast insight into the real operation of your device. Its fast waveform capture rate - greater than 500,000 waveforms per second - gives you a high probability of seeing the infrequent problems common in digital systems: runt pulses, glitches, timing issues, and more. To further enhance the visibility of rarely occurring events, intensity grading indicates how often rare transients are occurring relative to normal signal characteristics.



FastAcq's high waveform capture rate enables you to discover infrequent problems common in digital design.

Industry leading vertical resolution

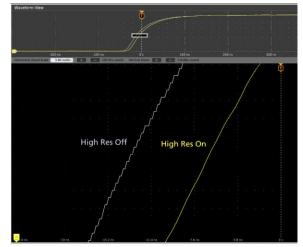
The 6 Series MSO provides the performance to capture the signals of interest while minimizing the effects of unwanted noise when you need to capture high-amplitude signals while seeing smaller signal details. At the heart of the 6 Series MSO are 12-bit analog-to-digital converters (ADCs) that provide 16 times the vertical resolution of traditional 8-bit ADCs.

A new High Res mode applies a hardware-based unique Finite Impulse Response (FIR) filter based on the selected sample rate. The FIR filter maintains the maximum bandwidth possible for that sample rate while preventing aliasing and removing noise from the oscilloscope amplifiers and ADC above the usable bandwidth for the selected sample rate.

High Res mode always provides at least 12 bits of vertical resolution and extends all the way to 16 bits of vertical resolution at \leq 625 MS/s sample rates and 200 MHz of bandwidth. The following table shows the number of bits of vertical resolution for each sample rate setting when in High Res.

Sample rate	Number of bits of vertical resolution
50 GS/s	8
25 GS/s	8
12.5 GS/s	12
6.25 GS/s	13
3.125 GS/s	14
1.25 GS/s	15
≤625 MS/s	16

New lower-noise front end amplifiers further improve the 6 Series MSO's ability to resolve fine signal detail.



The 6 Series MSO's 12-bit ADC, along with the new High Res mode, enable industry leading vertical resolution.

A new TEK061 front end amplifier sets a new standard for low-noise acquisition providing the best signal fidelity to capture small signals with high resolution.



A key attribute to being able to view fine signal details on small, high-speed signals is noise. The higher a measurement systems' intrinsic noise, the less true signal detail will be visible. This becomes more critical on an oscilloscope when the vertical settings are set to high sensitivity (like ≤ 10mV/div) in order to view small signals that are prevalent in high-speed bus topologies. The 6 Series MSO has a new front-end ASIC, the TEK061, that enables breakthrough noise performance at the highest sensitivity settings. The 'B' version of the 6 Series MSO has a new 50 GS/s low noise interleave sample rate on up to two channels that reduces noise by almost 3 dB at higher volts/div settings, furthering the advantage over competitive scopes in low noise performance. The table below shows a comparison of typical noise performance of the 6 Series MSO and prior generations of Tektronix oscilloscopes in this bandwidth range.

50 Ω, RMS voltage, typical

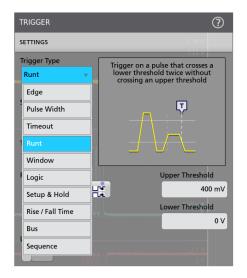
Bandwidth	V/Div	6 Series B MSO	DPO7000C	MSO/ DPO70000C
1 GHz	1 mV	51.8 µV	90 µV ³	N/A
	10 mV	82.9 µV	279 µV	N/A
	100 mV	829 µV	2.7 mV	N/A
4 GHz	1 mV	97.4 µV	N/A	N/A
	10 mV	171 µV	N/A	500 µV
	100 mV	1.73 mV	N/A	4.3 mV
8 GHz	1 mV	153 µV	N/A	N/A
	10 mV	287 µV	N/A	580 µV
	100 mV	2.94 mV	N/A	4.5 mV

Triggering

Discovering a device fault is only the first step. Next, you must capture the event of interest to identify root cause. The 6 Series MSO provides a complete set of advanced triggers, including:

- Runt
- Logic
- Pulse width
- Window
- Timeout
- Rise/Fall time
- Setup and Hold violation
- Serial packet
- Parallel data
- Sequence
- Video
- Visual Trigger
- RF Frequency vs. Time
- RF Magnitude vs. Time

With up to a 1 Gpoint record length, you can capture many events of interest, even thousands of serial packets in a single acquisition, providing high-resolution to zoom in on fine signal details and record reliable measurements.

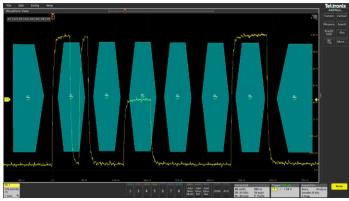


The wide variety of trigger types and context-sensitive help in the trigger menu make it easier than ever to isolate the event of interest.

Visual trigger - Finding the signal of interest quickly

Finding the right cycle of a complex bus can require hours of collecting and sorting through thousands of acquisitions for an event of interest. Defining a trigger that isolates the desired event speeds up debug and analysis efforts.

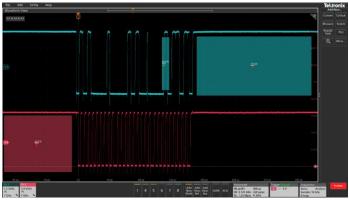
Visual Trigger extends the 6 Series MSO's triggering capabilities by scanning through all waveform acquisitions and comparing them to onscreen areas (geometric shapes). An unlimited number of areas can be created using a mouse or touchscreen, and a variety of shapes (triangles, rectangles, hexagons, or trapezoids) can be used to specify the desired trigger behavior. Once shapes are created, they can be edited interactively to create custom shapes and ideal trigger conditions.



Visual Trigger areas isolate an event of interest, saving time by only capturing the events you want to see.

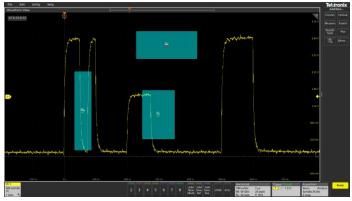
³ Bandwidth limited to 200 MHz.

By triggering only on the most important signal events, Visual Trigger can save hours of capturing and manually searching through acquisitions. In seconds or minutes, you can find the critical events and complete your debug and analysis efforts. Visual Trigger even works across multiple channels, extending its usefulness to complex system troubleshooting and debug tasks.



Multiple channel triggering. Visual Trigger areas can be associated with events spanning multiple channels such as packets transmitted on two bus signals simultaneously.

Once multiple areas are defined, a Boolean logic equation can be used to set complex trigger conditions using on-screen editing features.



Boolean logic trigger qualification. Boolean logic using logical OR allows triggering on a specific anomaly in the signal.

TekVPI Probe Interface

The TekVPI[®] probe interface sets the standard for ease of use in probing. In addition to the secure, reliable connection that the interface provides, many TekVPI probes feature status indicators and controls, as well as a probe menu button right on the comp box itself. This button brings up a probe menu on the oscilloscope display with all relevant settings and controls for the probe. The TekVPI interface enables direct attachment of current probes without requiring a separate power supply. TekVPI probes can be controlled remotely through USB or LAN, enabling more versatile solutions in ATE environments. The 6 Series MSO provides up to 80 W of power to the front panel connectors, sufficient to power all connected TekVPI probes without the need for an additional probe power supply.

Convenient high speed passive voltage probing

The TPP Series passive voltage probes included with every 6 Series MSO offer all the benefits of general-purpose probes - high dynamic range, flexible connection options, and robust mechanical design - while providing the performance of active probes. Up to 1 GHz analog bandwidth enables you to see high frequency components in your signals, and extremely low 3.9 pF capacitive loading minimizes adverse effects on your circuits and is more forgiving of longer ground leads.

An optional, low-attenuation (2X) version of the TPP probe is available for measuring low voltages. Unlike other low-attenuation passive probes, the TPP0502 has high bandwidth (500 MHz) as well as low capacitive loading (12.7 pF).



 $6~{\rm Series}$ MSOs come with standard one TPP1000 (1 GHz, 2.5 GHz models) probe per channel.

TDP7700 Series TriMode Probes

The TDP7700 Series TriMode probes provide the highest probe fidelity available for real-time oscilloscopes. The TDP7700 is designed for use with the 6 Series MSO, with full AC calibration of the probe and tip's signal path based on unique S-parameter models. The probe communicates the Sparameters to the scope via the TekVPI probe interface and the 6 Series MSO includes them to achieve the very best signal fidelity possible from probe tip to acquisition memory. Connectivity innovations such as solderdown tips with the probe's input buffer mounted only a few millimeters from the end of the tip, the TDP7700 Series probes provide unmatched usability for connecting to today's most challenging electronic designs.



TDP7700 Series probe with a selection of available tips

With TriMode probing one probe setup makes differential, single ended, and common mode measurements accurately. This unique capability allows you to work more effectively and efficiently, switching between differential, single ended and common mode measurements without moving the probe's connection point.

IsoVu[™] Isolated Measurement System

Whether designing an inverter, optimizing a power supply, testing communication links, measuring across a current shunt resistor, debugging EMI or ESD issues, or trying to eliminate ground loops in your test setup, common mode interference has caused engineers to design, debug, evaluate, and optimize "blind" until now.

Tektronix' revolutionary IsoVu technology uses optical communications and power-over-fiber for complete galvanic isolation. When combined with the 6 Series MSO equipped with the TekVPI interface, it is the first, and only, measurement system capable of accurately resolving high bandwidth, differential signals, in the presence of large common mode voltage with:

- Complete galvanic isolation
- Up to 1 GHz bandwidth
- 1 Million to 1 (120 dB) common mode rejection at 100 MHz
- 10,000 to 1 (80 dB) of common mode rejection at full bandwidth
- Up to 2,500 V differential dynamic range
- 60 kV common mode voltage range



The Tektronix TIVM Series IsoVu[™] Measurement System offers a galvanically isolated measurement solution to accurately resolve high bandwidth, differential signals up to 2,500 Vpk in the presence of large common mode voltages, with the best in class common mode rejection performance across its bandwidth.

Comprehensive analysis for fast insight

Basic waveform analysis

Verifying that your prototype's performance matches simulations and meets the project's design goals requires careful analysis, ranging from simple checks of rise times and pulse widths to sophisticated power loss analysis, characterization of system clocks, and investigation of noise sources.

The 6 Series MSO offers a comprehensive set of standard analysis tools including:

- Waveform- and screen-based cursors
- 36 automated measurements. Measurement results include all instances in the record, the ability to navigate from one occurrence to the next, and immediate viewing of the minimum or maximum result found in the record

- Basic waveform math
- Basic FFT analysis
- Advanced waveform math including arbitrary equation editing with filters and variables
- Spectrum view frequency domain analysis with independent controls for time and frequency domains
- FastFrame[™] Segmented Memory enables you to make efficient use of the oscilloscope's acquisition memory by capturing many trigger events in a single record while eliminating the large time gaps between events of interest. View and measure the segments individually or as an overlay.

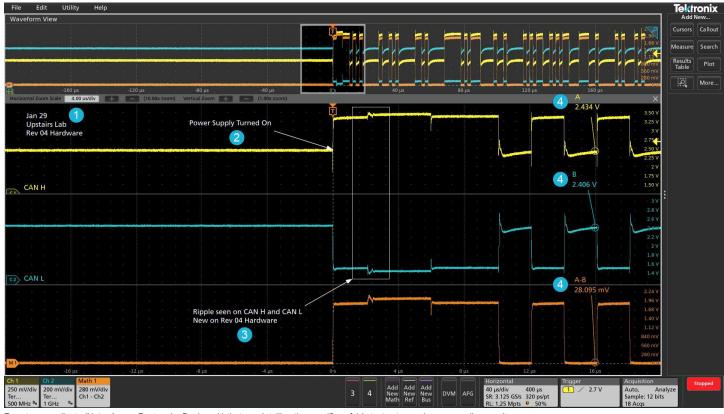
Measurement results tables provide comprehensive statistical views of measurement results with statistics across both the current acquisition and all acquisitions.



Using measurements to characterize burst width and Frequency.

Datasheet

Callouts



Easy to use callouts (Note, Arrow, Rectangle, Bookmark) that are detailing the specifics of this test setup and corresponding results.

- 1 Note Write and position a text box on the screen.
- **2** Arrow Write and position a text box, then add an arrow to a specific location on the screen.
- **3 Rectangle** Write text and outline a specific region on the screen indicated by a resizable box.
- **Bookmark** Create a dynamic readout at a specified time relative to a trigger point. This readout includes text, magnitude of the signal, signal units, as well as a line and target indicating the bookmark reference point.

Documenting test results and methods is critical when sharing data across a team, recreating a measurement at a later date, or delivering a customer report. With a few taps on the screen, you can create as many custom callouts as needed; enabling you to document the specific details of your test results. With each callout, you can customize the text, location, color, font size, and font.

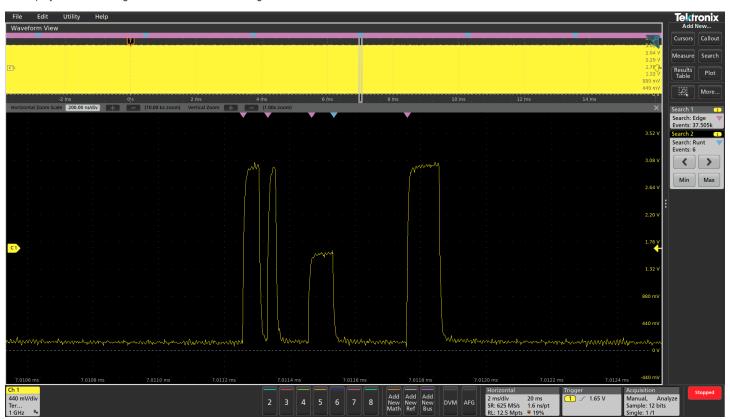
Navigation and search

Finding your event of interest in a long waveform record can be time consuming without the right search tools. With today's record lengths of many millions of data points, locating your event can mean scrolling through literally thousands of screens of signal activity.

The 6 Series MSO offers the industry's most comprehensive search and waveform navigation with its innovative Wave Inspector[®] controls. These controls speed panning and zooming through your record. With a unique force-feedback system, you can move from one end of your record to the other in just seconds. Or, use intuitive drag and pinch/expand gestures on the display itself to investigate areas of interest in a long record.

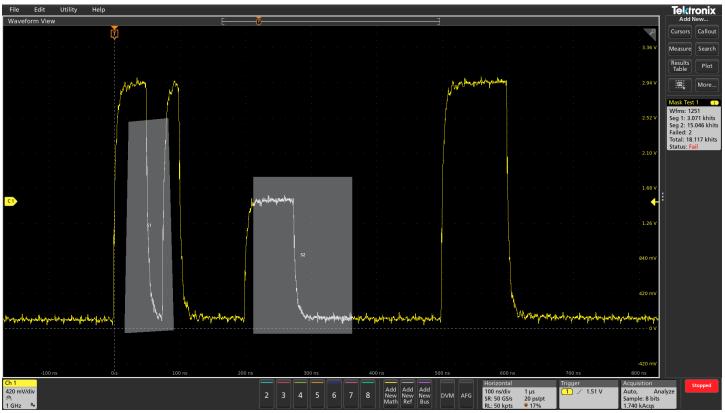
The Search feature allows you to automatically search through your long acquisition looking for user-defined events. All occurrences of the event are highlighted with search marks and are easily navigated to, using the Previous (\leftarrow) and Next (\rightarrow) buttons found on the front panel or on the Search badge on the display. Search types include edge, pulse width, timeout, runt, window, logic, setup and hold, rise/fall time and parallel/serial bus packet content. You can define as many unique searches as you like.

You can also quickly jump to the minimum and maximum value of search results by using the Min and Max buttons on the Search badge.



Earlier, FastAcq revealed the presence of a runt pulse in a digital data stream prompting further investigation.

Mask and limit testing (optional)



Custom, multiple segment mask capturing the presence of a signal glitch and runt pulse in a waveform.

Whether you are focused on signal integrity or setting up pass/fail conditions for production, mask testing is an efficient tool to characterize the behavior of certain signals in a system. Quickly create custom masks by drawing mask segments on the screen. Tailor a test to your specific requirements and set actions to take when a mask hit is registered, or when a complete test passes or fails.

Limit testing is an insightful way to monitor the long-term behavior of signals, helping you characterize a new design or confirm hardware performance during production line testing. Limit tests compare your live signal to an ideal, or golden version of the same signal with user-defined vertical and horizontal tolerances.

You can easily tailor a mask or limit test to your specific requirements by:

- · Defining test duration in number of waveforms
- Setting a violation threshold that must be met before considering a test a failure
- Counting violations/failures and reporting statistical information
- · Setting actions upon violations, test failure, and test complete

Serial protocol triggering and analysis (optional)

During debugging, it can be invaluable to trace the flow of activity through a system by observing the traffic on one or more serial buses. It could take many minutes to manually decode a single serial packet, much less the thousands of packets that may be present in a long acquisition.

And if you know the event of interest that you are attempting to capture occurs when a particular command is sent across a serial bus, wouldn't it be nice if you could trigger on that event? Unfortunately, it's not as easy as simply specifying an edge or a pulse width trigger.

File Edit Utility Help							
Waveform View	Bus D	ecode Results			×	Add	New
\mathbf{T}	Bus 1	(USB)				Cursors	Callout
\sim 2 M $_{\odot}$ = 1 M $_{\odot}$ =		371.7412µs	ACK			Measure	Search
		385.7413µs	OUT	4		Results	Plot
$1 \leq 1 \leq n \leq 1$	5	401.0747µs	DATA0		02 8B 16 83 C0 04 85 C0	Table	
	6	421.7416µs	ACK				More
0's 200 µs 40 µs 600 µs 100 µs 1.2'ms 1.4'ms 1.6'ms 4	7	435.7418µs	DATA0		01 00 11 11 11 11 42 08		
Horizontal Zoom Scale 340.00 ns/div + - (588.24x zoom) Vertical Zoom + - (1.00x zoom)	8	456.4086µs	ACK				
	9	470.4087µs	DATA0		65 22 01 8A 32 26 22 21		
and the second	10	491.0751µs	ACK				
	11	505.0753µs	DATA0		33 00 58 1C 22 18 24 26		
	12	525.7421µs	ACK				
	13	539.7424µs	DATA0		65 D5 88 84 11 11 02 6E		
	14	560.409µs	ACK				
	15	574.4088µs	DATA0		10 A7 00 00 00 C0 22 15		
	16	595.0761µs	ACK				
	17	609.0762µs	DATA0		10 11 0B B8 9D 04 88 45	1	
	18	629.743µs	ACK				
۵۱	19	643.7431µs	DATA0		26 12 8A A0 44 26 12 8A		
	20	664.4095µs	ACK				
	21	678.4098µs	DATA0		01 00 11 11 11 11 42 08		
	22	699.0766µs	ACK				
	23	713.0769µs	DATA0		65 22 01 8A 32 26 22 21		
	24	733.7433µs	ACK				
ετα δια τη μαίο της δια της την	25	747.7437µs	DATA0		33 00 58 1C 22 18 24 26		
which and the companies of the second second for the first first the	26	768.4104µs	ACK				
$\frac{1}{4}$	27	782.4105µs	DATA0		65 D5 88 84 11 11 02 6E		
	28	803.0773µs	ACK				
385.56 μs 385.90 μs 386.24 μs 386.58 μs 386.92 μs 387.26 μs 387.60 μs 387.94 μs 388.28 μs 388.62 μs	29	817.0774µs	DATA0		10 A7 00 00 00 C0 22 15		
	30	837.7441µs	ACK				
USB	31	851.7441µs	DATA0		10 11 0B B8 9D 04 88 45		
BI SYNC PID:OUT Addr:4 EndP:2h CRC:00h	32	872.4109µs	ACK				
	33	886.4111µs	DATA0		26 12 8A A0 44 26 12 8A		
	Add Add	Add	Horizontal	2 ms	Trigger Acquisition (B1) USB Auto, Ana	vze	Stopped
50 Ω 2 3 4 5 6 7 8	New New Math Ref	V New DVM	AFG SR: 625 MS/s	1.6 ns/pt	Token Packet Sample: 12 b		
1.5 GHz 👦			RL: 1.25 Mpts	9760 µs	Single: 1 /1		

Triggering on a USB full-speed serial bus. A bus waveform provides time-correlated decoded packet content including Start, Sync, PID, Address, End Point, CRC, Data values, and Stop, while the bus decode table presents all packet content from the entire acquisition.

The 6 Series MSO offers a robust set of tools for working with the most common serial buses found in embedded design including I²C, SPI, I3C, RS-232/422/485/UART, SPMI, CAN, CAN FD, LIN, FlexRay, SENT, PSI5, Automotive Ethernet, MIPI D-PHY, USB LS/FS/HS, eUSB 2.0, Ethernet 10/100, Audio (I²S/LJ/RJ/TDM), MIL-STD-1553, ARINC 429, Spacewire, 8B/10B, MDIO, SVID, Manchester, and NRZ.

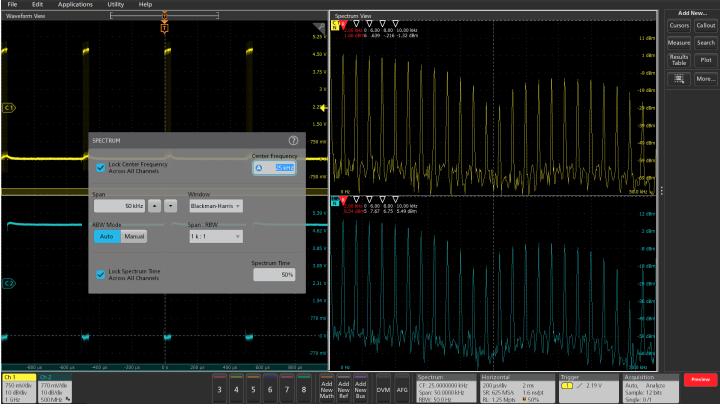
Serial protocol search enables you to search through a long acquisition of serial packets and find the ones that contain the specific packet content you specify. Each occurrence is highlighted by a search mark. Rapid navigation between marks is as simple as pressing the Previous (\leftarrow) and Next (\rightarrow) buttons on the front panel or in the Search badge that appears in the Results Bar.

The tools described for serial buses also work on parallel buses. Support for parallel buses is standard in the 6 Series MSO. Parallel buses can be up to 64 bits wide and can include a combination of analog and digital channels.

- Serial protocol triggering lets you trigger on specific packet content including start of packet, specific addresses, specific data content, unique identifiers, and errors.
- Bus waveforms provide a higher-level, combined view of the individual signals (clock, data, chip enable, and so on) that make up your bus, making it easy to identify where packets begin and end, and identifying sub-packet components such as address, data, identifier, CRC, and so on.
- The bus waveform is time aligned with all other displayed signals, making it easy to measure timing relationships across various parts of the system under test.
- Bus decode tables provide a tabular view of all decoded packets in an acquisition much like you would see in a software listing. Packets are time stamped and listed consecutively with columns for each component (Address, Data, and so on).

Datasheet

Spectrum View



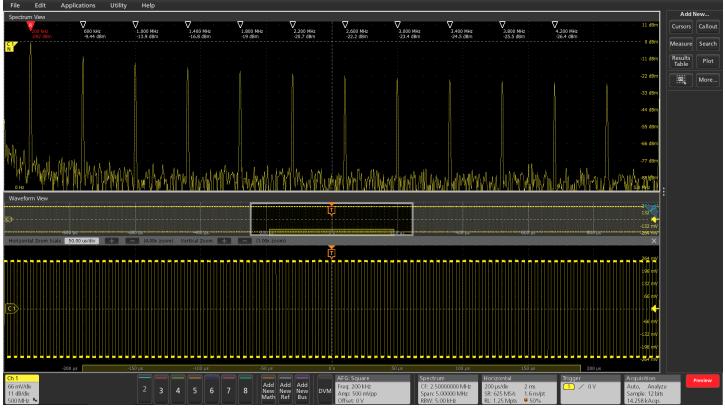
Intuitive spectrum analyzer controls like center frequency, span and resolution bandwidth (RBW), independent from time domain controls, provide easy setup for frequency domain analysis. A spectrum view is available for each FlexChannel analog input, enabling multi-channel mixed domain analysis.

It is often easier to debug an issue by viewing one or more signals in the frequency domain. Oscilloscopes have included math-based FFTs for decades in an attempt to address this need. However, FFTs are notoriously difficult to use for two primary reasons.

First, when performing frequency-domain analysis, you think about controls like Center Frequency, Span, and Resolution Bandwidth (RBW), as you would typically find on a spectrum analyzer. But then you use an FFT, where you are stuck with traditional scope controls like sample rate, record length and time/div and have to perform all the mental translations to try to get the view you're looking for in the frequency-domain.

Second, FFTs are driven by the same acquisition system that's delivering the analog time-domain view. When you optimize acquisition settings for the analog view, your frequency-domain view isn't what you want. When you get the frequency-domain view you want, your analog view is not what you want. With math-based FFTs, it is virtually impossible to get optimized views in both domains.

Spectrum View changes all of this. Tektronix' patented technology provides both a decimator for the time-domain and a digital downconverter for the frequency-domain behind each FlexChannel. The two different acquisition paths let you simultaneously observe both time- and frequency-domain views of the input signal with independent acquisition settings for each domain. Other manufacturers offer various 'spectral analysis' packages that claim ease-of-use, but they all exhibit the limitations described above. Only Spectrum View provides both exceptional ease-of-use and the ability to achieve optimal views in both domains simultaneously.

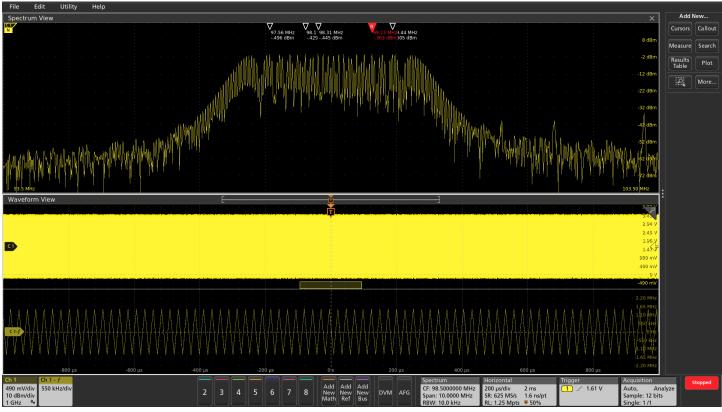


Spectrum Time gates the range of time where the FFT is being calculated. Represented by a small graphical rectangle in the time domain view, it can be positioned to provide time correlation with the time domain waveform. Perfect for conducting Mixed Domain Analysis. Up to 11 automated peak markers provide frequency and magnitude values of each peak. The Reference marker is always the highest peak shown and is indicated in red.

Visualizing changes in the RF signal (optional) – RF time domain traces make it easy to understand what's happening with a time-varying RF signal. There are three RF time domain traces that are derived from the underlying I and Q data of Spectrum View:

- Magnitude The instantaneous amplitude of the spectrum vs. time.
- Frequency The instantaneous frequency of the spectrum relative to the center frequency vs. time.
- Phase The instantaneous phase of the spectrum relative to the center frequency vs. time.

Each of these traces can be turned on and off independently, and all three can be displayed simultaneously.



The lower trace is the frequency vs. time trace derived from the input signal. Notice that the Spectrum Time is positioned during a transition from the lowest frequency to the middle frequency, so the energy is spread across a number of frequencies. With the frequency vs. time trace, you can easily see the different frequency hops, simplifying characterization of how the device switches between frequencies.

Triggering on changes in the RF signal (optional)

Whether you need to find the source of electromagnetic interference or understand the behavior of a VCO, hardware triggers for RF versus time make it easy to isolate, capture, and understand the RF signal behavior. Trigger on edges, pulse widths, and timeout behavior of RF magnitude vs. time and RF frequency vs. time.

Comprehensive vector signal analysis with SignalVu-PC (optional)

When analysis needs go beyond the basic spectrum, amplitude, frequency, and phase vs. time you can employ the SignalVu-PC vector signal analysis application. This enables in-depth transient RF signal analysis, detailed RF pulse characterization, and comprehensive analog and digital RF modulation analysis.

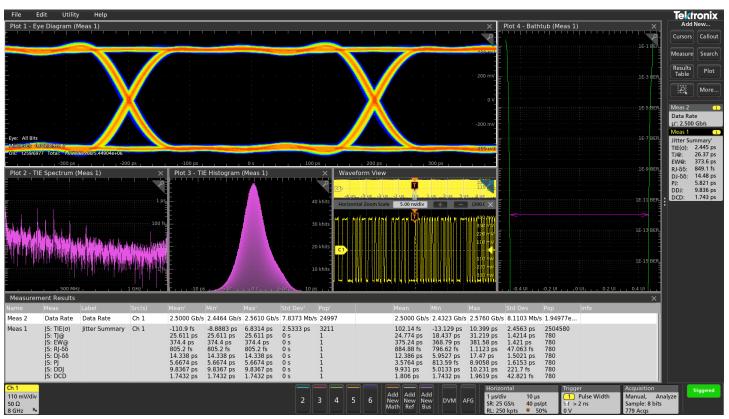
Three options are required to enable SignalVu-PC running on your 6 Series Oscilloscope. First, unless you plan to run the application from a separate Windows PC, the Windows SSD (6-WIN) needs to be installed in the scope. Second, the Spectrum View RF versus time traces option (6-SV-RFVT) needs to be installed in the scope to enable I/Q data to be transferred. Third, the Connect (CONxx-SVPC) license needs to be installed in SignalVu-PC to enable base features of SignalVu-PC, which includes 16+ RF measurements and displays. The RF digital down-converters and integrated measurement engines behind each channel have your complex mixed-signal and mixed-domain analysis needs covered in one instrument.



Jitter analysis

The 6 Series MSO has seamlessly integrated the DPOJET Essentials jitter and eye pattern analysis software package, extending the oscilloscope's capabilities to take measurements over contiguous clock and data cycles in a single-shot real-time acquisition. This enables measurement of key jitter and timing analysis parameters such as Time Interval Error and Phase Noise to help characterize possible system timing issues.

Analysis tools, such as plots for time trends and histograms, quickly show how timing parameters change over time, and spectrum analysis quickly shows the precise frequency and amplitude of jitter and modulation sources. Option 6-DJA adds additional jitter analysis capability to better characterize your device's performance. The 31 additional measurements provide comprehensive jitter and eye-diagram analysis and jitter decomposition algorithms, enabling the discovery of signal integrity issues and their related sources in today's high-speed serial, digital, and communication system designs. Option 6-DJA also provides eye diagram mask testing for automated pass/fail testing.



The unique Jitter Summary provides a comprehensive view of your device's performance in a matter of seconds.

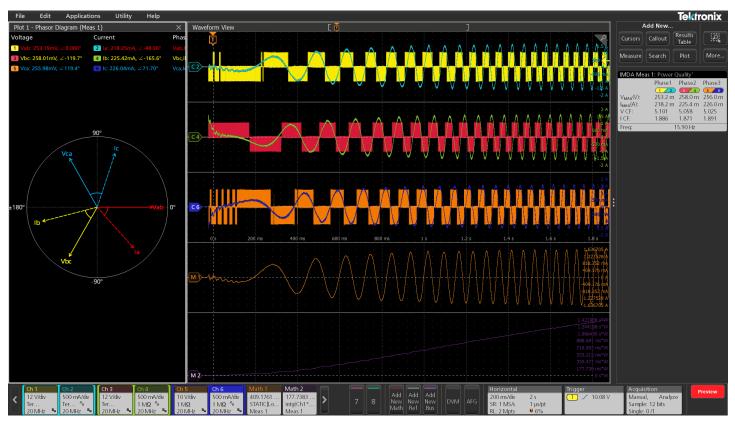
Power analysis (optional)

The 6 Series MSO has also integrated the optional 6-PWR power analysis package into the oscilloscope's automatic measurement system to enable quick and repeatable analysis of power quality, input capacitance, in-rush current, harmonics, switching loss, safe operating area (SOA), modulation, ripple, magnetics measurements, efficiency, amplitude and timing measurements, slew rate (dv/dt and di/dt), Control Loop Response (Bode Plot), and Power Supply Rejection Ratio (PSRR).

Measurement automation optimizes the measurement quality and repeatability at the touch of a button, without the need for an external PC or complex software setup.



The Power Analysis measurements display a variety of waveforms and plots.



Inverter Motor Drive Analysis (IMDA)(optional)

During the design and validation of systems that utilize 3-Phase power, it can be difficult to correlate control systems and power electronics with the performance of the overall system.

This will give you deeper insights enabling you to debug the design, efficiency and reliability of:

- 3-Phase power inverters, converters, power supplies, and automotive 3-Phase designs for DC-AC topology
- Motors (brushless AC, brushless DC, induction, permanent magnet, universal, stepper, rotor)
- Drives (AC, DC, variable frequency, servo)

The automated measurements that are included with 6-IMDA are:

- Input analysis
 - Power quality with phasor diagram
 - Harmonics
 - Input voltage
 - Input current
 - Input power
- Ripple analysis

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- Line Ripple
- Switching Ripple
- Output analysis
 - Phasor diagram
 - Efficiency
- Wiring configurations
 - 1 Volt/1 Current 1P2W
 - 2 Volt/2 Current 1P3W
 - 2 Volt/2 Current 3P3W
 - 3 Volt/3 Current 3P3W
 - 3 Volt/3 Current 3P4W

Compliance test

A key focus area for embedded designers is testing various embedded and interface technologies for compliance. This ensures the device passes the logo certification at plugfests and achieves successful interoperability when working with other compliant devices.

The compliance test specifications for high speed serial standards like USB, Ethernet, Memory, Display and MIPI are developed by the respective consortiums, or governing bodies. Working closely with these consortiums, Tektronix has developed oscilloscope-based compliance applications that not only focus on providing pass/fail results but also provide deeper insight into any failures by providing relevant measurement tools such as jitter and timing analysis to debug failing designs.

These automated compliance applications are built on a framework that provides:

- Complete test coverage per the specification.
- Fast test times with optimized acquisitions and test sequencing based on customized settings.
- Analysis based on previously-acquired signals, allowing the device under test (DUT) to be disconnected from the setup once all acquisitions are completed. This also allows analysis of waveforms acquired on a different oscilloscope or captured at a remote lab, facilitating a very collaborative test environment.
- Signal validation during acquisition to ensure the right signals are being captured.
- Additional parametric measurements for design debug.
- Custom eye diagram mask testing for insight into design margin.
- Detailed reports in multiple formats with setup information, results, margins, waveform screenshots and plot images.



TekExpress USB2 (Option 6-CMUSB2) DUT panel configures the DUT-specific settings

Designed with your needs in mind

Connectivity

The 6 Series MSO contains a number of ports which you can use to connect the instrument to a network, directly to a PC, or to other test equipment.

- Two USB 2.0 and one USB 3.0 host ports on the front and four more USB host ports (two 2.0, two 3.0) on the rear panel enable easy transfer of screen shots, instrument settings, and waveform data to a USB mass storage device. A USB mouse and keyboard can also be attached to USB host ports for instrument control and data entry.
- The rear panel USB Device port is useful for controlling the oscilloscope remotely from a PC.
- The standard 10/100/1000BASE-T Ethernet port on the rear of the instrument enables easy connection to networks and provides LXI Core 2011 compatibility.
- DVI-D, Display Port and VGA ports on the rear of the instrument lets you duplicate the instrument display on an external monitor or projector.



The I/O you need to connect the 6 Series MSO to the rest of your design environment.

Remote operation to improve collaboration

Want to collaborate with a design team on the other side of the world?

The embedded e*Scope[®] capability enables fast control of the oscilloscope over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Control the oscilloscope remotely in the exact same way that you do in-person. Alternatively, you can use Microsoft Windows Remote Desktop[™] capability to connect directly to your oscilloscope and control it remotely.

The industry-standard TekVISA[™] protocol interface is included for using and enhancing Windows applications for data analysis and documentation. IVI-COM instrument drivers are included to enable easy communication with the oscilloscope using LAN or USBTMC connections from an external PC.



e*Scope provides simple remote viewing and control using common web browsers.

PC-based analysis and remote connection to your scope

Get the analysis capability of an award-winning oscilloscope on your PC. Analyze waveforms anywhere, anytime. The basic package is free and lets you scale and measure waveforms. Purchased options add advanced capabilities such as multi-scope analysis, bus decoding, power analysis and jitter analysis.



TekScope PC analysis software runs on a Windows computer with the same awardwinning user experience as the 4, 5, and 6 Series MSO's. Key features of the TekScope PC analysis software include:

- Recall Tektronix oscilloscope sessions and waveform files from equipment made by Tektronix and other vendors. Waveform file formats supported include .wfm, .isf, .csv, .h5, .tr0, .trc, and .bin
- Remotely connect to Tektronix 4/5/6 Series MSOs to acquire data in real time
- Share data remotely with your colleagues so that they can perform analysis and make measurements as if they were sitting in front of the oscilloscope
- Synchronize waveforms from multiple oscilloscopes in real time
- Perform advanced analysis even if your oscilloscope isn't equipped with it

Arbitrary/Function Generator (AFG)

The instrument contains an optional integrated arbitrary/function generator, perfect for simulating sensor signals within a design or adding noise to signals to perform margin testing. The integrated function generator provides output of predefined waveforms up to 50 MHz for sine, square, pulse, ramp/triangle, DC, noise, sin(x)/x (Sinc), Gaussian, Lorentz, exponential rise/fall, Haversine and cardiac. The AFG can load waveform records up to 128 k points in size from an internal file location or a USB mass storage device.

The AFG feature is compatible with Tektronix' ArbExpress PC-based waveform creation and editing software, making creation of complex waveforms fast and easy.

Digital Voltmeter (DVM) and Trigger Frequency Counter

The instrument contains an integrated 4-digit digital voltmeter (DVM) and 8digit trigger frequency counter. Any of the analog inputs can be a source for the voltmeter, using the same probes that are already attached for general oscilloscope usage. The trigger frequency counter provides a very precise readout of the frequency of the trigger event on which you're triggering.

Both the DVM and trigger frequency counter are available for free and are activated when you register your product.

Enhanced security option

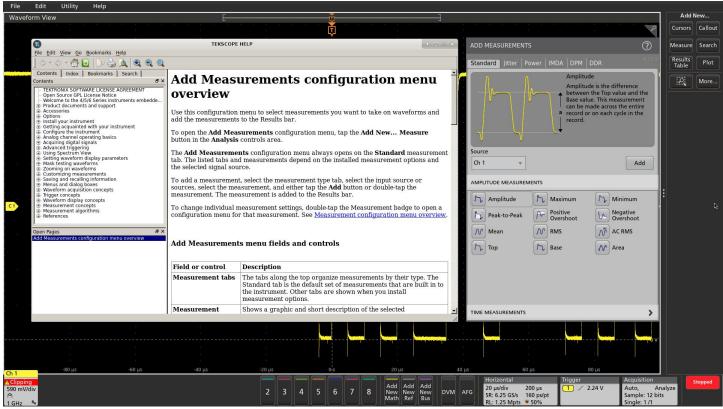
The optional 6-SEC enhanced security option enables password-protected enabling/disabling of all instrument I/O ports and firmware upgrades. In addition, a password protected BIOS is installed enabling protection to changes in the compute platform. Option 6-SEC is developed in compliance with National Industrial Security Program Operating Manual (NISPOM) DoD 5220.22-M, Chapter 8 requirements and Defense Security Service Manual for the Certification and Accreditation of Classified Systems under the NISPOM. This ensures that you can confidently move the instrument out of a secure area.

Sanitization of the instrument is easy, simply remove the SSD from the instrument and remove power. You can then remove the instrument from a secure environment for calibration or movement to a new location.

Help when you need it

The 6 Series MSO includes several helpful resources so you can get your questions answered rapidly without having to find a manual or go to a website:

- Graphical images and explanatory text are used in numerous menus to provide quick feature overviews.
- All menus include a question mark icon in the upper right that takes you directly to the portion of the integrated help system that applies to that menu.
- A short user interface tutorial is included in the Help menu for new users to come up to speed on the instrument in a matter of a few minutes.



Integrated help answers your questions rapidly without having to find a manual or go to the internet.

Specifications

All specifications are guaranteed and apply to all models unless noted otherwise.

Model overview

Oscilloscope

	MSO64B	MSO66B	MSO68B				
FlexChannel inputs	4	6	8				
Maximum analog channels	4	6	8				
Maximum digital channels (with optional logic probes)	32 48 64		64				
Bandwidth (calculated rise time)	1 GHz (400 ps), 2.5 GHz (160 ps), 4 GHz	(100 ps), 6 GHz (66.67 ps), 8 GHz (50 ps),	10 GHz (40 ps)				
DC Gain Accuracy	Gain Accuracy50 Ω : ±2.0% ⁴ at >2 mV/div (±2.0% at 2 mV/div typical, ±4% at 1 mV/div typical) 50 Ω : ±1.0% ⁵ of full scale at >2 mV/div, (±1.0% of full scale at 2 mV/div typical, ±2% at 1 mV/div typical) 1 M Ω : ±2.0% ⁴ at >2 mV/div (±2% at 2 mV/div, ±2.5% at 1 mV/div typical and 500 µV/div typical) 1 M Ω : ±1.0% ⁵ of full scale at >2 mV/div, (±1.0% of full scale at 2 mV/div typical, ±1.25% at 1 mV/div typical) 1 M Ω : ±1.0% ⁵ of full scale at >2 mV/div, (±1.0% of full scale at 2 mV/div typical, ±1.25% at 1 mV/div and 500 µV/div, typical)						
ADC Resolution	12 bits						
Vertical Resolution	8 bits @ 50 GS/s; 10 GHz on 2 channels 8 bits @ 25 GS/s; 10 GHz on 4 channels 12 bits @ 12.5 GS/s; 5 GHz on all channels 13 bits @ 6.25 GS/s (High Res); 2 GHz on all channels 14 bits @ 3.125 GS/s (High Res); 1 GHz on all channels 15 bits @ 1.25 GS/s (High Res); 500 MHz on all channels 16 bits @ ≤625 MS/s (High Res); 200 MHz on all channels						
Sample Rate	50 GS/s on 2 analog / digital channels (20 > 4 analog / digital channels (80 ps resolut	ps resolution); 25 GS/s on 4 analog / digital ion)	I channels (40 ps resolution); 12.5 GS/s on				
Record Length	62.5 Mpoints on all analog / digital channels, (125 Mpoints, 250 Mpoints, 500 Mpoints, and 1 Gpoints on all analog / digital channels optional)						
Waveform Capture Rate	>500,000 wfms/s (Peak Detect, Envelope acquisition mode), >30,000 wfms/s (all other acquisition modes)						
Arbitrary/Function Generator (opt.)	13 predefined waveform types with up to 5	i0 MHz output					
DVM	4-digit DVM (free with product registration)						
Trigger Frequency Counter	8-digit frequency counter (free with produc	t registration)					

Vertical system - analog channels

Input coupling	DC, AC
Input impedance 1 MΩ DC coupled	1 MΩ ±1%
Input capacitance 1 MΩ DC coupled, typical	14.5 pF ±1.5 pF
Input impedance 50 Ω , DC coupled	50 Ω ±3%
Input sensitivity range	
1 MΩ	500 μV/div to 10 V/div in a 1-2-5 sequence
	Note: 500 µV/div is a 2X digital zoom of 1 mV/div.

⁴ Immediately after SPC, add 2% for every 5 °C change in ambient.

⁵ Immediately after SPC, add 1% for every 5 °C change in ambient.

Datasheet

Vertical system - analog channels

50 Ω	1 mV/div to 1 V/div in a 1-2-5 sequence Note: 1 mV/div is a 2X digital zoom of 2 mV/div.
Maximum input voltage	50 Ω : 2.3 V _{RMS} at <100 mV/div, with peaks $\leq \pm 20$ V (DF $\leq 6.25\%$)
	50 Ω : 5.5 V _{RMS} at ≥100 mV/div, with peaks ≤ ±20 V (DF ≤ 6.25%)
	1 MΩ: 300 V _{RMS}
	For 1 M Ω , derate at 20 dB/decade from 4.5 MHz to 45 MHz;
	Derate at 14 dB/decade from 45 MHz to 450 MHz; > 450 MHz, 5.5 V_{RMS}

Effective bits (ENOB), typical

 $2\ mV/div,$ High Res mode, 50 $\Omega,$ 10 MHz input with 90% full screen

Bandwidth	ENOB
5 GHz	5.7
4 GHz	5.9
3 GHz	6.1
2.5 GHz	6.2
2 GHz	6.35
1 GHz	6.8
500 MHz	7.25
350 MHz	7.5
250 MHz	7.65
200 MHz	7.85
20 MHz	9.25

50 mV/div, High Res mode,						
50 Ω, 10 MHz input with 90%						
full screen						

Bandwidth	ENOB
5 GHz	7.4
4 GHz	7.6
3 GHz	7.85
2.5 GHz	7.95
2 GHz	8.1
1 GHz	8.45
500 MHz	8.65
350 MHz	8.8
250 MHz	8.85
200 MHz	8.9
20 MHz	9.85

Vertical system - analog channels

2 mV/div, Sample mode, 50 Ω,	Bandwidth	ENOB	7		
10 MHz input with 90% full	10 GHz	4.95	-		
screen	9 GHz	5.1	-		
	8 GHz	5.2	_		
	7 GHz	5.35	-		
	6 GHz	5.55	-		
	0 0112	0.00			
50 mV/div, Sample mode,	Bandwidth	ENOB	1		
50 $\Omega,$ 10 MHz input with 90%	10 GHz	6.6			
full screen	9 GHz	6.75	-		
	8 GHz	6.85	-		
	7 GHz	7	-		
	6 GHz	7.15	-		
	• • • • •				
osition range	±5 divisions				
ifset ranges, maximum					
noet ranges, maximum	Input signal cannot exceed ma	aximum input voltage for the 50 Ω input	path.		
	Volts/div Setting	Maximum offset range, 50 Ω In			
	1 mV/div - 99 mV/div	±1 V	•		
	100 mV/div - 1 V/div	±10 V			
		= 10 1			
	Volts/div Setting	Maximum offset range, 1 M Ω In	nput		
	Volts/div Setting 500 μV/div - 63 mV/div	Maximum offset range, 1 MΩ Ir ±1 V	nput		
			nput		
	500 µV/div - 63 mV/div	±1 V	nput		
ffact coourcou	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div	±1 V ±10 V	ıput		
-	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div	±1 V ±10 V ±100 V	iput		
ffset accuracy 50 Ohm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset –	±1 V ±10 V ±100 V	ıput		
•	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p	+1 V +10 V +100 V + 0.087 div) position + 0.13 div)	nput		
50 Ohm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p	+1 V +10 V +10 V +100 V - position + 0.087 div) position + 0.13 div) position + 0.224 div)	iput		
•	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p ≥5mV/div: ± (0.003 X offset - p	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.2 div)	iput		
50 Ohm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.2 div)	iput		
50 Ohm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p ≥5mV/div: ± (0.003 X offset - p	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.224 div) • position + 0.237 div)	1put		
	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.224 div) • position + 0.237 div) position + 0.384 div)	iput		
50 Ohm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.224 div) • position + 0.237 div) position + 0.384 div)	nput		
50 Ohm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 0ffset and position in units of 1	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.224 div) • position + 0.237 div) position + 0.384 div)		GHz, 5 GHz, 6 GH	z, 7 GHz, 8 GHz, 9 (
50 Ohm DC-coupled 1 MOhm DC-coupled	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div 25mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset -	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) • position + 0.224 div) • position + 0.224 div) • position + 0.237 div) position + 0.384 div) Volts	GHz, 3 GHz, 4 0		
50 Ohm DC-coupled 1 MOhm DC-coupled andwidth selections 10 GHz model, 50 Ohm	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div ≥5mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset -	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.224 div) • position + 0.237 div) position + 0.384 div) Volts 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5	GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 5 GHz, 6 GH	z, 7 GHz, and 8 GHz
50 Ohm DC-coupled 1 MOhm DC-coupled andwidth selections 10 GHz model, 50 Ohm 8 GHz model, 50 Ohm	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div 25mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset -	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.24 div) • position + 0.224 div) • position + 0.237 div) position + 0.384 div) Volts 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5	GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 5 GHz, 6 GH GHz, 5 GHz, and 6	z, 7 GHz, and 8 GHz
50 Ohm DC-coupled 1 MOhm DC-coupled andwidth selections 10 GHz model, 50 Ohm 8 GHz model, 50 Ohm 6 GHz model, 50 Ohm	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div 25mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 0ffset and position in units of 1 20 MHz, 200 MHz, 250 MHz, 3 and 10 GHz 20 MHz, 200 MHz, 250 MHz, 3 20 MHz, 200 MHz, 250	±1 V ±10 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.224 div) • position + 0.224 div) position + 0.237 div) position + 0.384 div) Volts 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5	GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, an	GHz, 5 GHz, 6 GH GHz, 5 GHz, and 6	z, 7 GHz, and 8 GHz
50 Ohm DC-coupled 1 MOhm DC-coupled andwidth selections 10 GHz model, 50 Ohm 8 GHz model, 50 Ohm 6 GHz model, 50 Ohm 4 GHz model, 50 Ohm	500 µV/div - 63 mV/div 64 mV/div - 999 mV/div 1 V/div - 10 V/div 25mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset - p 1mV/div: ± (0.003 X offset - p 2mV/div: ± (0.003 X offset -	±1 V ±10 V ±100 V ±100 V ±100 V • position + 0.087 div) position + 0.13 div) position + 0.24 div) • position + 0.237 div) position + 0.237 div) position + 0.384 div) Volts 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5	GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, 4 (GHz, 3 GHz, an	GHz, 5 GHz, 6 GH GHz, 5 GHz, and 6	z, 7 GHz, and 8 GHz

Datasheet

Vertical system - analog channels

Bandwidth filtering optimized for Flatness or Step response

Random noise, RMS, typical

50 Ω, typical

50 GS/s, Sample Mode, RMS									
V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/ div	1 V/div	
10 GHz	183 µV	188 µV	228 µV	346 µV	602 µV	1.39 mV	3.58 mV	27.4 mV	
9 GHz	167 µV	172 µV	208 µV	315 µV	549 µV	1.27 mV	3.22 mV	25 mV	
8 GHz	153 µV	156 µV	192 µV	287 µV	501 µV	1.15 mV	2.94 mV	23.1 mV	
7 GHz	139 µV	141 µV	175 µV	262 µV	457 µV	1.07 mV	2.68 mV	21.1 mV	
6 GHz	124 µV	127 µV	156 µV	234 µV	412 µV	949 µV	2.39 mV	19 mV	

25 GS/s, HiRes Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/ div	1 V/div
5 GHz	111 μV	112 µV	134 µV	197 µV	338 µV	772 µV	1.99 mV	15.4 mV
4 GHz	97.4 µV	98.7 µV	117 µV	171 µV	291 µV	672 µV	1.73 mV	13.3 mV
3 GHz	83.8 µV	85 µV	101 µV	144 µV	245 µV	559 µV	1.46 mV	11.2 mV
2.5 GHz	75.6 μV	76.6 µV	90.7 µV	128 µV	219 µV	498 µV	1.3 mV	9.85 mV
2 GHz	68.9 µV	69.9 µV	81.7 µV	116 µV	195 µV	444 µV	1.17 mV	8.78 mV
1 GHz	51.1 µV	51.8 µV	59.9 µV	82.9 µV	138 µV	314 µV	829 µV	6.22 mV
500 MHz	37.5 μV	38 µV	43.4 µV	60 µV	99.9 µV	230 µV	607 µV	4.61 mV
350 MHz	31.9 µV	32.3 µV	36.9 µV	49.9 µV	82.1 µV	185 µV	499 µV	3.62 mV
250 MHz	28.1 µV	28.5 µV	32.5 µV	44 µV	71.5 µV	161 µV	440 µV	3.19 mV
200 MHz	24.2 µV	24.5 µV	28 µV	37.9 µV	62.3 µV	140 µV	383 µV	2.78 mV
20 MHz	8.68 µV	8.8 µV	10.1 µV	13.8 µV	22.9 µV	52.8 µV	136 µV	1.04 mV

1 MΩ, High	Res	mode	(RMS),
typical			

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/ div	1 V/div
500 MHz	186 µV	202 µV	210 µV	236 µV	288 µV	522 µV	1.25 mV	13.4 mV
350 MHz	134 µV	138 µV	145 µV	163 µV	216 µV	391 µV	974 µV	10.6 mV
250 MHz	108 µV	110 µV	114 µV	131 µV	182 µV	374 µV	838 µV	9.63 mV
200 MHz	106 µV	108 µV	109 µV	117 µV	149 µV	274 µV	674 µV	8.01 mV
20 MHz	73 µV	73.2 µV	78.1 µV	99.6 µV	158 µV	361 µV	801 µV	8.29 mV

Crosstalk (channel isolation),	
typical	

≥50 dB up to 2 GHz ≥45 dB up to 5 GHz

≥40 dB up to 10 GHz

for any two channels set to 200 mV/div.

Vertical system - digital channels

Number of channels	8 digital inputs (D7-D0) per installed TLP058 (traded off for one analog channel)
Vertical resolution	1 bit
Maximum input toggle rate	500 MHz
Minimum detectable pulse width, typical	1 ns
Thresholds	One threshold per digital channel
Threshold range	±40 V
Threshold resolution	10 mV
Threshold accuracy	± [100 mV + 3% of threshold setting after calibration]
Input hysteresis, typical	100 mV at the probe tip
Input dynamic range, typical	30 V _{pp} for F _{in} \leq 200 MHz, 10 V _{pp} for F _{in} $>$ 200 MHz
Absolute maximum input voltage, typical	±42 V peak
Minimum voltage swing, typical	400 mV peak-to-peak
Input impedance, typical	100 κΩ
Probe loading, typical	2 pF

Front end and RF system (all measurements are typical)

Sensitivity/Noise density	-157 dBm/Hz (1 mV/div, -38 dBm, 1.0001 GHz CF, 500 kHz span, 3 kHz RBW)						
DANL	-163 dBm/Hz 10 MHz to 6 GHz, 1 mV/div						
	-160 dBm/Hz >6 GHz to 10 GHz, 1 mV/div						
Noise figure	17 dB (1 mV/div, -38 dBm, 1.001 GHz, 500 kHz span, 3 kHz RBW)						
SNR/Dyamic range	112 dB (1 GHz input carrier, 0 dBm scope input range, 1 GHz CF, 100 MHz span, 1 kHz RBW, measured ±20 MHz from center)						
Absolute amplitude accuracy	±1 dB (0 - 8 GHz) for max 10 GHz BW						
Phase noise @ 1GHz	10 MHz offset: -140 dBc/Hz						
	1 MHz offset: -132 dBc/Hz						
	100 kHz offset: -118 dBc/Hz						
	10 kHz offset: -118 dBc/Hz						
EVM (256 QAM)	0.5% @ 20 MSymbols/s						
	1.1% @ 800 MSymbols/s						
	1.5% @ 1.2 GSymbols/s						
	1.6% @ 2 GSymbols/s						

Datasheet

SFDR	60 dB @ 3 GHz, 5 GHz span										
	70 dB @ 2.35 GHz, 1	I.5 GHz sp	an								
Return Loss (<100 mV/div)	12 dB <5GHz										
	8 dB 5 GHz to 10 GH	lz									
Harmonic distortion	2nd Harmonic: -58 dl	BC with a 0) dBm, 1 Gł	Hz signal							
	3rd Harmonic: -55 dE	3C with a 0	dBm, 1 GF	lz signal							
Two-tone third order intercept	25 dBm 10 MHz to 6	GHz									
point (at 99 mV/div)	20 dBm 6 GHz to 8 G	Hz									
	12 dBm 8 GHz to 10	GHz									
orizontal system											
Time base range	40 ps/div to 1,000 s/c	liv									
Sample rate range	6.25 S/s to 50 GS/s (real time - maximum value depends on channels used)										
	25 GS/s to 2.5 TS/s (interpolated - minimum value depends on channels used)										
Record length range	Applies to analog and digital channels. All acquisition modes are 1 G maximum record length, down to 1 k minimum record length, adjustable in 1 sample increments.										
	Standard: 62.5 Mpoir	nts									
	Option 6-RL-1: 125 Mpoints										
	Option 6-RL-2: 250 Mpoints										
	Option 6-RL-3: 500 Mpoints										
	Option 6-RL-4: 1 Gpc	pints									
Seconds/Division range	Model	1 K	10 K	100 K	1 M	10 M	62.5 M	125 M	250 M	500 M	1 G
	MSO6xB Standard 62.5 M	40 ps - 16 s	400 ps - 160 s	4 ns - 10	00 s		2.5 µs - 1000 s	N/A	N/A	N/A	N/A
	MSO6xB Option 6- RL-1 125 M	40 ps - 16 s	400 ps - 160 s	4 ns - 10	00 s		2.5 µs - 1000 s	5 µs - 1000 s	N/A	N/A	N/A
	MSO6xB Option 6-	40 ps -	400 ps -	4 ps - 10	00 s		2.5 µs -	5 µs -	10 µs -	N/A	N/A

Aperture uncertainty (sample jitter)	Time duration	Typical jitter
	<1 µs	80 fs
	<1 ms	130 fs

RL-2 250 M

MSO6xB Option 6-

MSO6xB Option 6-

RL-3 500 Mpts

RL-4: 1 Gpts

16 s

16 s

16 s

40 ps -

40 ps -

160 s

160 s

160 s

400 ps -

400 ps -

4 ps - 1000 s

4 ps - 1000 s

1000 s

2.5 us -

1000 s

2.5 us -

1000 s

1000 s

5 us -

1000 s

5 us -

1000 s

1000 s

10 us -

1000 s

10 us -

1000 s

20 us -

1000 s

20 us -

1000 s

N/A

40 us -

1000 s

Horizontal system

Timebase accuracy

 $\pm 1.0 \text{ x}10^{-7}$ over any ≥ 1 ms time interval

Description	Specification
Factory Tolerance	±12 ppb At calibration, 25 °C ambient, over any ≥1 ms interval
Temperature stability	± 20 ppb across the full operating range of 0 °C to 50 °C, after a sufficient soak time at the temperature Tested at operating temperatures
Crystal aging	± 300 ppb. Frequency tolerance change at 25 °C over a period of 1 year

Delta-time measurement accuracy, nominal

$$DTA_{RMS} = \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + t_j^2} + TBA \times t_p$$

(assume edge shape that results from Gaussian filter response)

The formula to calculate delta-time measurement accuracy (DTA) for a given instrument setting and input signal assumes insignificant signal content above Nyquist frequency, where:

SR₁ = Slew Rate (1st Edge) around 1st point in measurement

SR₂ = Slew Rate (2nd Edge) around 2nd point in measurement

N = RSS of input-referred noise (V_{RMS}) and dynamic noise estimate (volts rms)

Dynamic noise estimate* =
$$\sqrt{\frac{BW}{8 GHz}} X 19.9 X 10^{-3} X volts/div$$

TBA = time base accuracy or reference frequency error (which is 20 ppb)

t_i = aperture uncertainty (sec rms -80 fs for short durations)

t _p = delta-time measurement duration (sec)

Maximum duration at highest sample rate	1.25 ms (std.) or 2.5 ms (opt. 6-RL-1, 125 Mpoints), 5 ms (opt. 6-RL-2, 250 Mpoints), 10 ms (opt. 6-RL-3, 500 Mpoints), or 20 ms (Opt. 6-RL-4, 1 Gpoints)
Time base delay time range	-10 divisions to 5,000 s
Deskew range	-125 ns to +125 ns with a resolution of 40 ps (for Peak Detect and Envelope acquisition modes).
	-125 ns to +125 ns with a resolution of 1 ps (for all other acquisition modes).
Delay between analog channels, full bandwidth, typical	\leq 10 ps for any two channels with input impedance set to 50 Ω , DC coupling with equal Volts/div or above 10 mV/div
Delay between analog and digital FlexChannels, typical	< 1 ns when using a TLP058 and a passive probe matching the bandwidth of the scope, with no bandwidth limits applied
Delay between any two digital FlexChannels, typical	320 ps
Delay between any two bits of a digital FlexChannel, typical	160 ps

Datasheet

Trigger system

Trigger modes	Auto, Normal, and Single							
Trigger coupling	DC, HF Reject (attenuates > 50 kHz), LF Reject (attenuates < 50 kHz), noise reject (reduces sensitivity)							
Trigger bandwidth (edge, pulse	Model			Trigger type	Trigger bandwidth			
and logic), typical	MSO6xB 10 GHz			Edge	10 GHz			
	MSO6xB 10 GHz			Pulse, Logic	4 GHz			
	MSO6xB 8 GHz			Edge	8 GHz			
	MSO6xB 8 GHz			Pulse, Logic	4 GHz			
	MSO6xB 6 GHz			Edge	6 GHz			
	MSO6xB 6 GHz			Pulse, Logic	4 GHz			
	MSO6xB 4 GHz, 2	.5 GHz, 1 Gł	Ηz	Edge, Pulse, Logic	Product Bandwidth			
Edge-type trigger sensitivity, DC	Path	Range		Specification				
coupled, typical	1 MΩ path (all models)	0.5 mV/div to 0.99 mV/div		5 mV from DC to instrument bandwidth				
		≥ 1 mV/div		The greater of 5 mV or 0.7 div from DC to lesser of 500 MHz or instrument BW, & 6 mV or 0.8 div from > 500 MHz to instrument bandwidth				
	50 Ω path 1 mV/div t 1.99 mV/d			3.5 div from DC to instrument bandwidth				
		2 mV/div to 4.99 mV/div ≥ 5 mV/div		2 divisions from DC to instrument bandwidth				
				< 5 division from DC to instrument bandwidth				
	Line	90 V to 264 V line voltage at 50 - 60 Hz line frequency		e 103.5 V to 126.5 V				
	AUX Trigger in			250 mV _{PP} , DC to 400 MHz				
Edge-type trigger sensitivity, not	Trigger Coupling		Typical	Sensitivity				
DC coupled, typical	NOISE REJ		2.5 times the DC Coupled limits					
	HF REJ		1.0 times the DC Coupled limits from DC to 50 kHz. Attenuates signals above 50 kHz.					
				imes the DC Coupled limits for frequencies above 50 kHz. Attenuates signals below 50 kH				
Trigger jitter, typical	≤ 1.5 ps _{RMS} for sam							
	≤ 2 ps _{RMS} for edge-type trigger and FastAcq mode ≤ 80 ps _{PP} for non edge-type trigger modes							
Trigger jitter, AUX input, typical	≤ 200 ps _{RMS} for edge-type trigger and FastAcq mode							

±100 ps jitter on each instrument with 1.5 ns skew; ≤1.7 ns total between instruments. With manual deskewing of individual

channels, total instrument skew can reach 200 ps between different instrument channels. Skew improves for pulse input voltages ≥1 V_{pp}

AUX In trigger skew between

instruments, typical

Trigger system

Trigger lovel

Trigger level ranges	Source	Range
	Any Channel	±5 divs from center of screen
	Aux In Trigger	±5 V
	Line	Fixed at about 50% of line voltage
	This specification applies to	o logic and pulse thresholds.
Trigger frequency counter	8-digits (free with product r	registration)
Trigger types		
Edge:	Positive, negative, or eithe	r slope on any channel. Coupling includes DC, AC, noise reject, HF reject, and LF reject
Pulse Width:	Trigger on width of positive	or negative pulses. Event can be time- or logic-qualified
Timeout:	Trigger on an event which	remains high, low, or either, for a specified time period. Event can be logic-qualified
Runt:	Trigger on a pulse that crost time- or logic-qualified	sses one threshold but fails to cross a second threshold before crossing the first again. Event can be
Window:	Trigger on an event that er can be time- or logic-qualif	nters, exits, stays inside or stays outside of a window defined by two user-adjustable thresholds. Event ied
Logic:		goes true, goes false, or occurs coincident with a clock edge. Pattern (AND, OR, NAND, NOR) specified ed as high, low, or don't care. Logic pattern going true can be time-qualified
Setup & Hold:	Trigger on violations of bot	h setup time and hold time between clock and data present on any input channels
Rise / Fall Time:	Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either. Event can be logic- qualified	
Video (option 6-VID):	Trigger on all lines, odd, ev	ven, or all fields of NTSC, PAL, and SECAM video signals
Sequence:	Trigger on B event X time or N events after A trigger with a reset on C event. In general, A and B trigger events can be set to any trigger type with a few exceptions: logic qualification is not supported, if A event or B event is set to Setup & Hold, then the other must be set to Edge, and Ethernet and High Speed USB (480 Mbps) are not supported	
Visual trigger	Qualifies standard triggers by scanning all waveform acquisitions and comparing them to on-screen areas (geometric shapes). An unlimited number of areas can be defined with In, Out, or Don't Care as the qualifier for each area. A boolean expression can be defined using any combination of visual trigger areas to further qualify the events that get stored into acquisition memory. Shapes include rectangle, triangle, trapezoid, hexagon and user-defined.	
Parallel Bus:	Trigger on a parallel bus data value. Parallel bus can be from 1 to 32 bits (from the digital and analog channels) in size. Supports Binary and Hex radices	
I ² C Bus (option 6-SREMBD):	Trigger on Start, Repeated Start, Stop, Missing ACK, Address (7 or 10 bit), Data, or Address and Data on I ² C buses up to 10 Mb/s	
SPI Bus (option 6-SREMBD):	Trigger on Slave Select, Id	le Time, or Data (1-16 words) on SPI buses up to 20 Mb/s
RS-232/422/485/UART Bus (option 6-SRCOMP):	Trigger on Start Bit, End of	f Packet, Data, and Parity Error up to 15 Mb/s
CAN Bus (option 6-SRAUTO):	Trigger on Start of Frame, Type of Frame (Data, Remote, Error, or Overload), Identifier, Data, Identifier and Data, End Of Frame, Missing Ack, and Bit Stuff Error on CAN buses up to 1 Mb/s	
CAN FD Bus (option 6- SRAUTO):	Trigger on Start of Frame, Type of Frame (Data, Remote, Error, or Overload), Identifier (Standard or Extended), Data (1-8 bytes), Identifier and Data, End Of Frame, Error (Missing Ack, Bit Stuffing Error, FD Form Error, Any Error) on CAN FD buses up to 16 Mb/s	
LIN Bus (option 6-SRAUTO):	Trigger on Sync, Identifier, Data, Identifier and Data, Wakeup Frame, Sleep Frame, and Error on LIN buses up to 1 Mb/s	
FlexRay Bus (option 6- SRAUTO):	Trigger on Start of Frame, Indicator Bits (Normal, Payload, Null, Sync, Startup), Frame ID, Cycle Count, Header Fields (Indicator Bits, Identifier, Payload Length, Header CRC, and Cycle Count), Identifier, Data, Identifier and Data, End Of Frame, and Errors on FlexRay buses up to 10 Mb/s	
SENT Bus (option 6- SRAUTOSEN)	Trigger on Start of Packet, Fast Channel Status and Data, Slow Channel Message ID and Data, and CRC Errors	
SPMI Bus (option 6-SRPM):	Trigger on Sequence Start Condition, Reset, Sleep, Shutdown, Wakeup, Authenticate, Master Read, Master Write, Register Read, Register Write, Extended Register Read, Extended Register Write, Extended Register Read Long, Extended Register Write Long, Device Descriptor Block Master Read, Device Descriptor Block Slave Read, Register 0 Write, Transfer Bus Ownership, and Parity Error	
USB 2.0 LS/FS/HS Bus (option 6-SRUSB2):	Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special Packet, Error on USB buses up to 480 Mb/s	

Trigger system

Datasheet

rigger system		
Ethernet Bus (option 6- SRENET):	Trigger on Start of Frame, MAC Addresses, MAC Q-tag, MAC Length/Type, MAC Data, IP Header, TCP Header, TCP/IPV4 Data, End of Packet, and FCS (CRC) Error on 10BASE-T and 100BASE-TX buses	
Audio (I ² S, LJ, RJ, TDM) Bus (option 6-SRAUDIO):	Trigger on Word Select, Frame Sync, or Data. Maximum data rate for I ² S/LJ/RJ is 12.5 Mb/s. Maximum data rate for TDM is 25 Mb/s	
MIL-STD-1553 Bus (option 6- SRAERO):	Trigger on Sync, Command (Transmit/Receive Bit, Parity, Subaddress / Mode, Word Count / Mode Count, RT Address), Status (Parity, Message Error, Instrumentation, Service Request, Broadcast Command Received, Busy, Subsystem Flag, Dynamic Bus Control Acceptance, Terminal Flag), Data, Time (RT/IMG), and Error (Parity Error, Sync Error, Manchester Error, Non-contiguous Data) on MIL-STD-1553 buses	
ARINC 429 Bus (option - SRAERO):	Trigger on Word Start, Label, Data, Label and Data, Word End, and Error (Any Error, Parity Error, Word Error, Gap Error) on ARINC 429 buses up to 1 Mb/s	
RF Magnitude vs. Time and RF Frequency vs. Time (option 6-SV- RFVT)	Trigger on edge, pulse width, and timeout events	
Trigger holdoff range	0 ns to 10 seconds	

Acquisition system

Sample	Acquires sampled values	
Peak Detect	Captures glitches as narrow as 160 ps at all sweep speeds	
Averaging	From 2 to 10,240 waveforms	
Envelope	Min-max envelope reflecting Peak Detect data over multiple acquisitions	
High Res	Applies a unique Finite Impulse Response (FIR) filter for each sample rate that maintains the maximum bandwidth possible for that sample rate while preventing aliasing and removing noise from the oscilloscope amplifiers and ADC above the usable bandwidth for the selected sample rate.	
	High Res mode always provides at least 12 bits of vertical resolution and extends all the way to 16 bits of vertical resolution at \leq 625 MS/s sample rates.	
FastAcq®	FastAcq optimizes the instrument for analysis of dynamic signals and capture of infrequent events.	
	Maximum waveform capture rate:	
	>500,000 wfms/s (Peak Detect or Envelope Acquisition mode)	
	>30,000 wfms/s (All other acquisition modes)	

Acquisition system

Roll mode	Scrolls sequential waveform points across the display in a right-to-left rolling motion, at timebase speeds of 40 ms/div and slower, when in Auto trigger mode.
FastFrame™	Acquisition memory divided into segments.
	Maximum trigger rate >5,000,000 waveforms per second
	Minimum frame size = 50 points
	For record lengths up to 250M, and for frame size ≥ 1,000 points, maximum number of frames = record length / frame size.
	For record lengths of 500M, and when only channels capable of a maximum sample rate of \geq 25GS/s are used, maximum number of frames = record length / frame size.
	For record lengths of 500M, and when any channels capable of a maximum sample rate of 12.5 GS/s are used, maximum number of frames is ≥ 250,000.
	For record lengths of 1G, and when only channels capable of a maximum sample rate of \ge 25 GS/s are used, maximum number o frames \ge record length / frame size / 2.
	For record lengths of 1G, and when only channels capable of a maximum sample rate of 12.5 GS/s are used, maximum number of frames \geq record length / frame size / 4.
	For 50 point frames, maximum number of frames = 1,000,000

Waveform measurements

Average of ≥ to waveforms ±(DC Gain Accuracy + 0.15 div + 0.6 mV) Delta volts between any two averages of ≥ 16 waveforms ±(DC Gain Accuracy + 0.15 div + 0.6 mV) Automatic measurements 36, of which an unlimited number can be displayed as either individual measurement badges or collectively in a measurement setuits table Automatic measurements 36, of which an unlimited number can be displayed as either individual measurement badges or collectively in a measurem results table Amplitude measurements Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Bas Area Timing measurements Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Tim Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, S Time, Hold Time, Duration N-Periods, High Time, and Low Time Jitter measurements (standard) TIE and Phase Noise Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or set to global for all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only or gate is available for Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can to Global) or Local (all measurements can have a uni	Cursor types	Waveform, V Bars, H Bars, V&H Bars, and Polar (XY/XYZ plot	s only)	
Average or ≥ to waveforms ±(DC Gain Accuracy + 0.15 div + 0.6 mV) Delta volts between any two averages of ≥ 16 waveforms ±(DC Gain Accuracy + 0.15 div + 0.6 mV) Automatic measurements 36, of which an unlimited number can be displayed as either individual measurement badges or collectively in a measurements Automatic measurements 36, of which an unlimited number can be displayed as either individual measurement badges or collectively in a measurement sults table Amplitude measurements Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Bas Area Timing measurements Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Tim Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, S Time, Hold Time, Duration N-Periods, High Time, and Low Time Jitter measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or set to global for all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only c gate is available for Screen, Cursors, Logic, and Search actions).		Measurement Type	DC Accuracy (In Volts)	
acquired with the same oscilloscope setup and ambient conditions acquired with the same oscilloscope setup and ambient conditions Automatic measurements 36, of which an unlimited number can be displayed as either individual measurement badges or collectively in a measurem results table Amplitude measurements Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Bas Area Timing measurements Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Tim Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, 3 Time, Hold Time, Duration N-Periods, High Time, and Low Time Jitter measurements (standard) TIE and Phase Noise Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or set to global for all measurements, per source channel or signal, or unique for each measurement Gating Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only or gate is available for Screen, Cursors, Logic, and Search actions).	accuracy, Average acquisition mode	Average of ≥ 16 waveforms	±(DC Gain Accuracy * reading - (offset - position) + Offset Accuracy + 0.15 div + 0.6 mV)	
Amplitude measurements Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Bas Area Timing measurements Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Tin Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, to Time, Hold Time, Duration N-Periods, High Time, and Low Time Jitter measurements (standard) TIE and Phase Noise Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or set to global for all measurements, per source channel or signal, or unique for each measurement. Gating can to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only or gate is available for Screen, Cursors, Logic, and Search actions).		acquired with the same oscilloscope setup and ambient	±(DC Gain Accuracy * reading + 0.15 div + 1.2 mV)	
Area Fining measurements Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Tim Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, S Time, Hold Time, Duration N-Periods, High Time, and Low Time Jitter measurements (standard) TIE and Phase Noise Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or 	Automatic measurements		dividual measurement badges or collectively in a measurement	
Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, S Time, Hold Time, Duration N-Periods, High Time, and Low Time Jitter measurements (standard) TIE and Phase Noise Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or set to global for all measurements, per source channel or signal, or unique for each measurement Gating Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating car to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only c gate is available for Screen, Cursors, Logic, and Search actions).	Amplitude measurements	Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Overshoot, Negative Overshoot, Mean, RMS, AC RMS, Top, Base, and Area		
Measurement statistics Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition an acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels or set to global for all measurements, per source channel or signal, or unique for each measurement Gating Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only or gate is available for Screen, Cursors, Logic, and Search actions).	Timing measurements	Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Time, Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, Setup Time, Hold Time, Duration N-Periods, High Time, and Low Time		
acquisitions Reference levels User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels of set to global for all measurements, per source channel or signal, or unique for each measurement Gating Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only c gate is available for Screen, Cursors, Logic, and Search actions).	Jitter measurements (standard)	TIE and Phase Noise		
Gating Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating car to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only c gate is available for Screen, Cursors, Logic, and Search actions).	Measurement statistics		n. Statistics are available on both the current acquisition and all	
to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only c gate is available for Screen, Cursors, Logic, and Search actions).	Reference levels	User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels can be set to global for all measurements, per source channel or signal, or unique for each measurement		
Measurement plots Histogram, Time Trend, Spectrum, Eye Diagram (TIE measurement only), Phase Noise (Phase Noise measurement only)	Gating	Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can be se to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only one Loc gate is available for Screen, Cursors, Logic, and Search actions).		
	Measurement plots	Histogram, Time Trend, Spectrum, Eye Diagram (TIE measurement only), Phase Noise (Phase Noise measurement only)		

Waveform measurements

Measurement limits	Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions	
Jitter analysis (option 6-DJA) adds the following:		
Measurements	Jitter Summary, TJ@BER, RJ- δδ, DJ- δδ, PJ, RJ, DJ, DDJ, DCD, SRJ, J2, J9, NPJ, F/2, F/4, F/8, Eye Height, Eye Height@BER Eye Width, Eye Width@BER, Eye High, Eye Low, Q-Factor, Bit High, Bit Low, Bit Amplitude, DC Common Mode, AC Common Mode (Pk-Pk), Differential Crossover, T/nT Ratio, SSC Freq Dev, SSC Modulation Rate	
Measurement plots	Eye Diagram and Jitter Bathtub	
	Fast eye rendering: Shows the Unit Intervals (UIs) that define the boundaries of the eye along with a user specified number of surrounding UIs for added visual context	
	Complete eye rendering: Shows all valid Unit Intervals (UIs)	
Measurement limits	Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions	
Eye diagram mask testing	Automated mask pass/fail testing	
Power analysis (option 6-PWR) adds the following:		
Measurements	Input Analysis (Frequency, V _{RMS} , I _{RMS} , voltage and current Crest Factors, True Power, Apparent Power, Reactive Power, Power Factor, Phase Angle, Harmonics, Inrush Current, Input Capacitance)	
	Amplitude Analysis (Cycle Amplitude, Cycle Top, Cycle Base, Cycle Maximum, Cycle Minimum, Cycle Peak-to-Peak)	
	Timing Analysis (Period, Frequency, Negative Duty Cycle, Positive Duty Cycle, Negative Pulse Width, Positive Pulse Width)	
	Switching Analysis (Switching Loss, dv/dt, di/dt, Safe Operating Area, R _{DSon})	
	Output Analysis (Line Ripple, Switching Ripple, Efficiency, Turn-on Time, Turn-off Time)	
	Magnetic Analysis (Inductance, I vs. Intg(V), Magnetic Loss, Magnetic Property)	
	Frequency Response Analysis (Control Loop Response Bode Plot, Power Supply Rejection Ratio, Impedance)	
Measurement Plots	Harmonics Bar Graph, Switching Loss Trajectory Plot, and Safe Operating Area	
Measurement limits	Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions	
Inverter Motor Drive Analysis (option 6-IMDA) adds the following:		
Measurements	Input Analysis (Power Quality, Harmonics, Input Voltage, Input Current, Input Power)	
	Ripple analysis (Line ripple, Switching Ripple)	
	Output analysis (Phasor Diagram, Efficiency)	
	DQ0 analysis (DQ0) Requires option 6-IMDA-DQ0	
Measurement plots	Harmonics Bar Graph, Phasor Diagram	
Digital power management (option 6-DPM) adds the following:		
Measurements	Ripple Analysis (Ripple)	
	Transient Analysis (Overshoot, Undershoot, Turn On Overshoot, DC Rail Voltage)	
	Power Sequence Analysis (Turn-on, Turn-off)	
	Jitter Analysis (TIE, PJ, RJ, DJ, Eye Height, Eye Width, Eye High, Eye Low)	

Waveform measurements

DDR3/LPDDR3 memory debug and analysis option (6-DBDDR3) adds the following:		
Measurements	Amplitude Measurements (AOS, AUS, Vix(ac), AOS Per tCK, AUS Per tCK, AOS Per UI, AUS Per UI)	
	Time Measurements (tRPRE, tWPRE, tPST, Hold Diff, Setup Diff, tCH(avg), tCK(avg), tCL(avg), tCH(abs), tCL(abs), tJIT(duty), tJIT(per), tJIT(cc), tERR(n), tERR(m-n), tDQSCK, tCMD-CMD, tCKSRE, tCKSRX)	
LVDS debug and analysis option (option 6-DBLVDS) adds the following:		
Data Lane Measurements	Generic Test (Unit Interval, Rise Time, Fall Time, Data Width, Data Intra Skew (PN), Data Inter Skew (Lane-to-Lane), Data Peak- to-Peak)	
	Jitter Test (AC Timing, Clock Data Setup Time, Clock Data Hold Time, Eye Diagram (TIE), TJ@BER, DJ Delta, RJ Delta, DDJ, De- Emphasis Level)	
Clock Lane Measurements	Generic Test (Frequency, Period, Duty Cycle, Rise Time, Fall Time, Clock Intra Skew (PN), Clock Peak-to-Peak)	
	Jitter Test (TIE, DJ, RJ)	
	SSC On (Mod Rate, Frequency Deviation Mean)	

Waveform math

Number of math waveforms	Unlimited	
Arithmetic	Add, subtract, multiply, and divide waveforms and scalars	
Algebraic expressions	Define extensive algebraic expressions including waveforms, scalars, user-adjustable variables, and results of parametric measurements. Perform math on math using complex equations. For example (Integral (CH1 - Mean(CH1)) X 1.414 X VAR1)	
Math functions	Invert, Integrate, Differentiate, Square Root, Exponential, Log 10, Log e, Abs, Ceiling, Floor, Min, Max, Degrees, Radians, Sin, Cos, Tan, ASin, ACos, and ATan	
Relational	Boolean result of comparison >, <, \geq , \leq , =, and \neq	
Logic	AND, OR, NAND, NOR, XOR, and EQV	
Filtering function	User-definable filters. Users specify a file containing the coefficients of the filter	
FFT functions	Spectral Magnitude and Phase, and Real and Imaginary Spectra	
FFT vertical units	Magnitude: Linear and Log (dBm)	
	Phase: Degrees, Radians, and Group Delay	
FFT window functions	Hanning, Rectangular, Hamming, Blackman-Harris, Flattop2, Gaussian, Kaiser-Bessel, and TekExp	

Spectrum view

Center Frequency	Limited by instrument analog bandwidth			
Span	74.5 Hz – 1.25 GHz			
	74.5 Hz - 2 GHz (with option 6-SV-BW-1)			
	Coarse adjustment in a 1-2-5 sequence			
RF vs. Time Traces	Magnitude vs. time, Frequency vs. time, Phase	Magnitude vs. time, Frequency vs. time, Phase vs. time (with option 6-SV-RFVT)		
RF vs. Time Trigger	Edge, pulse width, and timeout trigger on RF Magnitude vs. Time and RF Frequency vs. Time (with option 6-SV-RFVT)			
Resolution Bandwidth (RBW)	93 µHz to 62.5 MHz			
	93 μHz to 100 MHz (with option 6-SV-BW-1)			
Window types and factors	Window type	Factor		
	Blackman-Harris	1.90		
	Flat-Top 2	3.77		
	Hamming	1.30		
	Hanning	1.44		
	Kaiser-Bessel	2.23		
	Rectangular	0.89		
Spectrum Time	FFT Window Factor / RBW			
Reference level	rence level Reference level is automatically set by the analog channel Volts/div setting			
	Setting range: -42 dBm to +44 dBm			
Vertical Position	-100 divs to +100 divs			
Vertical units	dBm, dBµW, dBmV, dBµV, dBmA, dBµA			
Vertical scaling	Linear, Log			
Horizontal scaling	Linear, Log			
earch				
Number of searches	Unlimited			
Search types	Search through long records to find all occurrences of user specified criteria including edges, pulse widths, timeouts, runt pulses, window violations, logic patterns, setup & hold violations, rise/fall times, and bus protocol events. Search results can be viewed in the Waveform View or in the Results table.			

Save

Waveform Type	Tektronix Waveform Data (.wfm), Comma Separated Values (.csv), MATLAB (.mat)	
Waveform Gating	Cursors, Screen, Resample (save every nth sample)	
Screen Capture Type	Portable Network Graphic (*.png), 24-bit Bitmap (*.bmp), JPEG (*.jpg)	
Setup Type	Tektronix Setup (.set)	
Report Type	Adobe Portable Documents (.pdf), Single File web Pages (.mht)	
Session Type	Tektronix Session Setup (.tss)	
Display		
Display type	15.6 in. (395 mm) liquid-crystal TFT color display	
Resolution	1,920 horizontal × 1,080 vertical pixels (High Definition)	
Display modes Overlay: traditional oscilloscope display where traces overlay each other		
	Stacked: display mode where each waveform is placed in its own slice and can take advantage of the full ADC range while still being visually separated from other waveforms. Groups of channels can also be overlaid within a slice to simplify visual comparison of signals.	
Zoom	Horizontal and vertical zooming is supported in all waveform and plot views.	
Interpolation	Sin(x)/x and Linear	
Waveform styles	Vectors, dots, variable persistence, and infinite persistence	
Graticules	Movable and fixed graticules, selectable between Grid, Time, Full, and None	
Color palettes	Normal and inverted for screen captures	
	Individual waveform colors are user-selectable	
Fonts	Font size is user selectable from 12 to 20 (default is 15)	
Format	YT, XY, and XYZ	
Local Language User Interface	English, Japanese, Simplified Chinese, Traditional Chinese, French, German, Italian, Spanish, Portuguese, Russian, Korean	
Local Language Help	English, Japanese, Simplified Chinese	

Arbitrary function generator (optional)

Function types

Arbitrary, sine, square, pulse, ramp, triangle, DC level, Gaussian, Lorentz, exponential rise/fall, sin(x)/x, random noise, Haversine, Cardiac

Amplitude range

Values are peak-to-peak voltages

Waveform	50 Ω	1 MΩ
Arbitrary	10 mV to 2.5 V	20 mV to 5 V
Sine	10 mV to 2.5 V	20 mV to 5 V
Square	10 mV to 2.5 V	20 mV to 5 V
Pulse	10 mV to 2.5 V	20 mV to 5 V
Ramp	10 mV to 2.5 V	20 mV to 5 V
Triangle	10 mV to 2.5 V	20 mV to 5 V
Gaussian	10 mV to 1.25 V	20 mV to 2.5 V
Lorentz	10 mV to 1.2 V	20 mV to 2.4 V
Exponential Rise	10 mV to 1.25 V	20 mV to 2.5 V
Exponential Fall	10 mV to 1.25 V	20 mV to 2.5 V
Sine(x)/x	10 mV to 1.5 V	20 mV to 3.0 V
Random Noise	10 mV to 2.5 V	20 mV to 5 V
Haversine	10 mV to 1.25 V	20 mV to 2.5 V
Cardiac	10 mV to 2.5 V	20 mV to 5 V

Sine waveform

Frequency range	0.1 Hz to 50 MHz
Frequency setting resolution	0.1 Hz
Frequency accuracy	130 ppm (frequency \leq 10 kHz), 50 ppm (frequency > 10 kHz)
	This is for Sine, Ramp, Square and Pulse waveforms only.
Amplitude range	20 mV_{pp} to 5 V_{pp} into Hi-Z; 10 mV_{pp} to 2.5 V_{pp} into 50 Ω
Amplitude flatness, typical	±0.5 dB (relative to 1kHz level) at 30 MHz
	±1.0 dB (relative to 1kHz level) at 50 MHz
Total harmonic distortion,	1% for amplitude \geq 200 mVpp into 50 Ω load
typical	2.5% for amplitude > 50 mV AND < 200 mVpp into 50 Ω load
Spurious free dynamic range, typical	40 dB (V_{pp} \geq 0.1 V); 30 dB (V_{pp} \geq 0.02 V), 50 Ω load

Square and pulse waveform

Y	are and pulse wavelorni		
	Frequency range	0.1 Hz to 25 MHz	
	Frequency setting resolution	0.1 Hz	
	Frequency accuracy	130 ppm (frequency ≤ 10 kHz), 50 ppm (frequency > 10 kHz)	
	Amplitude range	20 mV _pp to 5 V _pp into Hi-Z; 10 mV _pp to 2.5 V _pp into 50 Ω	
	Duty cycle range	10% - 90% or 10 ns minimum pulse, whichever is larger	
		Minimum pulse time applies to both on and off time, so maximum duty cycle will reduce at higher frequencies to maintain 10 ns off time	
	Duty cycle resolution	0.1%	
	Minimum pulse width, typical	10 ns. This is the minimum time for either on or off duration.	
	Rise/Fall time, typical	5 ns, 10% - 90%	
	Pulse width resolution	100 ps	

6 Series B MSO

Arbitrary function generator (optional)

Overshoot, typical	< 6% for signal steps greater than 100 mV _{pp}	
oversnoot, typical		
Asymmetry typical	This applies to overshoot of the positive-going transition (+overshoot) and of the negative-going (-overshoot) transition	
Asymmetry, typical	$\pm 1\% \pm 5$ ns, at 50% duty cycle	
Jitter, typical	< 60 ps TIE _{RMS} , \ge 100 mV _{pp} amplitude, 40%-60% duty cycle Square and pulse waveforms, 5 GHz measurement BW.	
Ramp and triangle waveform		
Frequency range	0.1 Hz to 500 kHz	
Frequency setting resolution	0.1 Hz	
Frequency accuracy	130 ppm (frequency \leq 10 kHz), 50 ppm (frequency $>$ 10 kHz)	
Amplitude range	20 mV _{pp} to 5 V _{pp} into Hi-Z; 10 mV _{pp} to 2.5 V _{pp} into 50 Ω	
Variable symmetry	0% - 100%	
Symmetry resolution	0.1%	
DC level range	±2.5 V into Hi-Z	
	±1.25 V into 50 Ω	
Random noise amplitude range	20 mV _{pp} to 5 V _{pp} into Hi-Z	
	10 mV $_{\text{pp}}$ to 2.5 V $_{\text{pp}}$ into 50 Ω	
in(x)/x		
Maximum frequency	2 MHz	
Gaussian pulse, Haversine, and		
orentz pulse		
Maximum frequency	5 MHz	
orentz pulse		
Frequency range	0.1 Hz to 5 MHz	
Amplitude range	20 mV _{pp} to 2.4 V _{pp} into Hi-Z	
	10 mV_{pp} to 1.2 V_{pp} into 50 Ω	
ardiac		
Frequency range	0.1 Hz to 500 kHz	
Amplitude range	20 mV _{pp} to 5 V _{pp} into Hi-Z	
-	10 mV _{pp} to 2.5 V _{pp} into 50 Ω	
rbitrary		
Memory depth	1 to 128 k	
Amplitude range	20 mV_{pp} to 5 V _{pp} into Hi-Z	
1	10 mV _{pp} to 2.5 V _{pp} into 50 Ω	
Repetition rate	0.1 Hz to 25 MHz	
Sample rate	250 MS/s	
-		
Signal amplitude accuracy	±[(1.5% of peak-to-peak amplitude setting) + (1.5% of absolute DC offset setting) + 1 mV] (frequency = 1 kHz)	
Signal amplitude resolution	1 mV (Hi-Z)	
	500 μV (50 Ω)	

Arbitrary function generator (optional)

DC offset range	±2.5 V into Hi-Z
	±1.25 V into 50 Ω
DC offset resolution	1 mV (Hi-Z)
	500 μV (50 Ω)
DC offset accuracy	±[(1.5% of absolute offset voltage setting) + 1 mV]
	Add 3 mV of uncertainty per 10 °C change from 25 °C ambient

Digital Volt Meter (DVM)

DC, AC _{RMS} +DC, AC _{RMS} , Trigger frequency count	
4 digits	
±((1.5% * reading - offset - position) + (0.5% * (offset - position)) + (0.1 * Volts/div))	
De-rated at 0.100%/°C of reading - offset - position above 30 °C	
Signal ± 5 divisions from screen center	
\pm 3% (40 Hz to 1 kHz) with no harmonic content outside 40 Hz to 1 kHz	
AC, typical: ± 2% (20 Hz to 10 kHz)	
For AC measurements, the input channel vertical settings must allow the V _{PP} input signal to cover between 4 and 10 divisions and must be fully visible on the screen	

Trigger frequency counter

Resolution	8-digits	
Accuracy ±(1 count + time base accuracy * input frequency)		
	The signal must be at least 8 mV $_{\rm pp}$ or 2 div, whichever is greater.	
Input frequency	10 Hz to maximum bandwidth of the analog channel	
The signal must be at least 8 mV $_{\rm pp}$ or 2 div, whichever is greater.		

Processor system

ost processor Intel Core i5-8400H @2.5 GHz, 64-bit, quad core processor	
Standard SSD with Embedded OS ≥ 250 GB removable solid state drive	
Operating system Instrument with option 6-WIN installed: Microsoft Windows 10	
Solid State Drive (SSD) with Microsoft Windows 10 OS (option 6-WIN)≥ 500 GB SSD. Form factor is a 2.5-inch SSD with a SATA-3 interface. This drive is customer installable and Microsoft Windows 10 Enterprise IoT 2016 LTSB (64-bit) operating system	

Input-Output ports

DisplayPort connector	A 20-pin DisplayPort connecto	or; connect to show the oscilloscope display on an external monitor or projector	
DVI connector	A 29-pin DVI-I connector; con	nect to show the oscilloscope display on an external monitor or projector	
VGA	DB-15 female connector; conr	nect to show the oscilloscope display on an external monitor or projector	
Probe compensator signal, typical			
Connection:	Connectors are located on the	e lower front right of the instrument	
Amplitude:	0 to 2.5 V		
Frequency:	1 kHz		
Source impedance:	1 kΩ		
External reference input	The time-base system can phase lock to an external 10 MHz reference signal .		
	There are two ranges for the reference clock.		
	The instrument can accept a h ±1 kppm.	high-accuracy reference clock of 10 MHz ± 2 ppm or a lower-accuracy reference clock of 10 MHz	
USB interface (Host, Device ports)	Front panel USB Host ports: Two USB 2.0 Hi-Speed ports, one USB 3.0 SuperSpeed port		
	Rear panel USB Host ports: Two USB 2.0 Hi-Speed ports, two USB 3.0 SuperSpeed ports		
	Rear panel USB Device port:	One USB 3.0 SuperSpeed Device port providing USBTMC support	
Ethernet interface	10/100/1000 Mb/s		
Auxiliary output	Rear-panel BNC connector. Output can be configured to provide a positive or negative pulse out when the oscilloscope triggers, the internal oscilloscope reference clock out, or an AFG sync pulse		
	Characteristic	Limits	
	Vout (HI)	\geq 2.5 V open circuit; \geq 1.0 V into a 50 Ω load to ground	
	Vout (LO)	\leq 0.7 V into a load of \leq 4 mA; \leq 0.25 V into a 50 Ω load to ground	
Kensington-style lock	Rear-panel security slot conne	ects to standard Kensington-style lock	
LXI	Class: LXI Core 2011		
	Version: 1.5		

Power source

Power	
Power consumption	500 Watts maximum
Source voltage	100 - 240 V $\pm 10\%$ at 50 Hz to 60 Hz
	115 V ±10% at 400 Hz

Physical characteristics

Dimensions	Height: 12.2 in (309 mm), feet folded in, handle to back
	Height: 14.6 in (371 mm) feet folded in, handle up
	Width: 17.9 in (454 mm) from handle hub to handle hub
	Depth: 8.0 in (205 mm) from back of feet to front of knobs, handle up
	Depth: 11.7 in (297.2 mm) feet folded in, handle to the back
Weight	< 28.4 lbs (12.88 kg)
Cooling	The clearance requirement for adequate cooling is 2.0 in (50.8 mm) on the right side of the instrument (when viewed from the front) and on the rear of the instrument
Rackmount configuration	7U (with optional RM5 Rackmount Kit)

Environmental specifications

Temperature	
Operating	+0 °C to +50 °C (32 °F to 122 °F)
Non-operating	-20 °C to +60 °C (-4 °F to 140 °F)
Humidity	
Operating	5% to 90% relative humidity (% RH) at up to +40 °C
	5% to 55% RH above +40 °C up to +50 °C, noncondensing
Non-operating	5% to 90% relative humidity (% RH) at up to +60 °C, noncondensing
Altitude	
Operating	Up to 3,000 meters (9,843 feet)
Non-operating	Up to 12,000 meters (39,370 feet)

EMC environment and safety

Regulatory	CE marked for the European Union and UL approved for the USA and Canada	
	RoHS compliant	
oftware		
Software		
IVI driver	Provides a standard instrument programming interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET, and MATLAB. Compatible with Python, C/C++/C# and many other languages through VISA.	
e*Scope [®]	Enables control of the oscilloscope over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Transfer and save settings, waveforms, measurements, and screen images or make live control changes to settings on the oscilloscope directly from the web browser.	
LXI Web interface	Connect to the oscilloscope through a standard Web browser by simply entering the oscilloscope's IP address or network name in the address bar of the browser. The Web interface enables viewing of instrument status and configuration, status and modificatio of network settings, and instrument control through the e*Scope web-based remote control.	
Programming Examples	Programming with the 4/5/6 Series platforms has never been easier. With a programmers manual and a GitHub site you have many commands and examples to help you get started remotely automating your instrument. See https://github.com/tektronix/ Programmatic-Control-Examples.	

Ordering information

Use the following steps to select the appropriate instrument and options for your measurement needs.

Step 1

Start by selecting the model.

Model	Number of FlexChannels
MSO64B	4
MSO66B	6
MSO68B	8

Each model includ	es
One TPP1000 1 GH	z probe per FlexChannel
Installation and safe	ty manual (translated in English, Japanese, Simplified Chinese)
Embedded Help	
Front cover with inte	grated accessory pouch
Mouse	
Power cord	
Calibration certificate registration	e documenting traceability to National Metrology Institute(s) and ISO9001/ISO17025 quality system
	covering all parts and labor on the instrument. covering all parts and labor on included probes

Step 2

Configure your oscilloscope by selecting the analog channel bandwidth you need

Choose the bandwidth you need today by choosing one of these bandwidth options. You can upgrade it later by purchasing an upgrade option.

Bandwidth Option	Bandwidth
6-BW-1000	1 GHz
6-BW-2500	2.5 GHz
6-BW-4000	4 GHz
6-BW-6000	6 GHz
6-BW-8000	8 GHz
6-BW-10000	10 GHz

Note: For instruments of 4, 6, 8 or 10 GHz bandwidth, consider a BNC-to-SMA adapter to optimize a high bandwidth connection to the oscilloscope. Tektronix part number 103-0503-XX.

Step 3

Add instrument functionality

Instrument functionality can be ordered with the instrument or later as an upgrade kit.

Instrument Option	Built-in Functionality
6-RL-1	Extend record length from 62.5 Mpoints/channel to 125 Mpoints/channel
6-RL-2	Extend record length from 62.5 Mpts/channel to 250 Mpts/channel
6-RL-3	Extend record length from 62.5 Mpoints/channel to 500 Mpoints/channel
6-RL-4	Extend record length from 62.5 Mpoints/channel to 1 Gpoints/channel
6-AFG	Add Arbitrary / Function Generator
6-SEC ⁶	Add enhanced security for instrument declassification and password-protected enabling and disabling of all USB ports and firmware upgrade.
6-WIN	Add removable SSD with Microsoft Windows 10 operating system license

Step 4

Add optional serial bus triggering, decode, and search capabilities

Choose the serial support you need today by choosing from these serial analysis options. You can upgrade later by purchasing an upgrade kit.

Instrument Option	Serial Buses Supported
6-SRAERO	Aerospace (MIL-STD-1553, ARINC 429)
6-SRAUDIO	Audio (I ² S, LJ, RJ, TDM)
6-SRAUTO	Automotive (CAN, CAN FD, LIN, FlexRay, and CAN symbolic decoding)
6-SRAUTOEN1	100BASE-T1 Automotive Ethernet serial analysis
6-SRAUTOSEN	Automotive sensor (SENT)
6-SRCOMP	Computer (RS-232/422/485/UART)
6-SRDPHY	MIPI D-PHY (DSI-1, CSI-2 decode and search only)
6-SREMBD	Embedded (I ² C, SPI)
6-SRENET	Ethernet (10BASE-T, 100BASE-TX)
6-SR8B10B	8B/10B (decode and search only)
6-SRI3C	MIPI I3C (I3C decode and search only)
6-SRMANCH	Manchester (decode and search only)
6-SRMDIO	MDIO (decode and search only)
6-SRNRZ	NRZ (decode and search only)
6-SRPM	Power Management (SPMI)
6-SRPSI5	PSI5 (decode and search only)
6-SRSPACEWIRE	Spacewire (decode and search only)
6-SRSVID	SVID (decode and search only)
6-SRUSB2	USB (USB2.0 LS, FS, HS)
6-SREUSB2	eUSB2.0 (decode and search only)

Differential serial bus? Be sure to check Add analog probes and adapters for differential probes.

⁶ This option must be purchased at the same time as the instrument. Not available as an upgrade.

Add third party serial bus decode and analysis capabilities

Third-party applications are available that provide serial bus decode and analysis capabilities for use on the 6 Series B MSO. Tektronix part numbers listed below can be ordered directly from Tektronix or through an authorized distributor. Ordered application software will be shipped directly by the third-party. Use of the third-party software applications require a Windows 10 SSD (option 6-WIN).

Tektronix Part Number	Serial Buses Supported
PGY-EMMC	Embedded Multi-media Controller (eMMC) memory
PGY-QSPI	Quad Serial Peripheral Interface (QSPI) - 2 enhanced IO lines for SPI
PGY-SDIO	Secure Digital Input Output (SDIO)

Step 5

Add optional serial bus compliance testing

Choose the serial compliance testing packages you need today by choosing from these options. You can upgrade later by purchasing an upgrade kit. All options in the table below require option 6-WIN (SSD with Microsoft Windows 10 operating system).

Instrument Option	Serial Buses Supported
6-CMAUTOEN	Automotive Ethernet (100Base-T1, 1000Base-T1) automated compliance test solution. ≥2 GHz bandwidth required for 1000BASE-T1
6-CMAUTOEN10	Automotive Ethernet (10BASE-T1S Short Reach) automated compliance test solution.
6-AUTOEN-BND	Automotive Ethernet Compliance, Signal Separation, PAM3 Analysis, 100Base-T1 Decode software (requires options 6-DJA and 6-WIN)
6-AUTOEN-SS	Automotive Ethernet Signal Separation
6-CMINDUEN10	Industrial Ethernet (10Base-T1L Long Reach) automated compliance test solution
6-CMDPHY	MIPI D-DPHY 1.2 automated compliance test solution.
6-CMENET	Ethernet automated compliance test solution (10BASE-T/100BASE-T/1000BASE-T). ≥1 GHz bandwidth required for 1000BASE-T
6-CMNBASET	2.5 and 5 GBASE-T Ethernet automated compliance test solution.2.5 GHz is recommended
6-CMXGBT	10 GBASE-T Ethernet automated compliance test solution. ≥4 GHz is recommended
6-CMUSB2	USB2.0 automated compliance test solution. Requires TDSUSBF USB test fixture ≥2 GHz bandwidth required for high-speed USB

Step 6

Add optional memory analysis

Instrument Option	Advanced Analysis
6-DBDDR3	DDR3 and LPDDR3 Debug and Analysis
6-CMDDR3	DDR3 and LPDDR3 automated compliance test solution using TekExpress Automation Platform. Requires options 6-DBDDR3, 6-DJA and 6-WIN (SSD with Microsoft Windows 10 operating system). ≥4 GHz required, 8 GHz recommended for testing of all DDR3 speeds.

Step 7

Add optional analysis capabilities

Instrument Option	Advanced Analysis
6-DBLVDS	TekExpress automated LVDS test solution (requires options 6-DJA and 6-WIN)
6-DJA	Advanced Jitter and Eye Analysis
6-DPM	Digital Power Management
6-IMDA 7	Inverter motor drive analysis
6-IMDA-DQ0 7	DQ0 feature for inverter motor drive analysis
6-MTM	Mask and Limit testing
6-PAM3	PAM3 Analysis (requires options 6-DJA and 6-WIN)
6-PS2 ⁸	Power solution bundle (6-PWR, THDP0200, TCP0030A, 067-1686-XX deskew fixture)
6-PWR ⁹	Power Measurement and Analysis
6-SV-BW-1	Increase Spectrum View Capture Bandwidth to 2 GHz
6-SV-RFVT	Spectrum View RF versus Time analysis and remote IQ data transferring
6-VID	NTSC, PAL, and SECAM video triggering

Step 8

Add digital probes

Each FlexChannel input can be configured as eight digital channels simply by connecting a TLP058 logic probe.

For this instrument	Order	To add
MSO64B	1 to 4 TLP058 Probes	8 to 32 digital channels
MSO66B	1 to 6 TLP058 Probes	8 to 48 digital channels
MSO68B	1 to 8 TLP058 Probes	8 to 64 digital channels

⁷ This option is not compatible with MSO64B.

⁸ This option is not compatible with option 6-PWR.

⁹ This option is not compatible with option 6-PS2.

Step 9

Add analog probes and adapters

Add additional recommended probes and adapters

Recommended Probe / Adapter	Description
TAP1500	1.5 GHz TekVPI® active single-ended voltage probe, ±8 V input voltage
TAP2500	2.5 GHz TekVPI® active single-ended voltage probe, ±4 V input voltage
TAP3500	3.5 GHz TekVPI® active single-ended voltage probe, ±4 V input voltage
TAP4000	4 GHz TekVPI® active single-ended voltage probe, ±4 V input voltage
TCP0020	20 A AC/DC TekVPI [®] current probe, 50 MHz BW
TCP0030A	30 A AC/DC TekVPI current probe, 120 MHz BW
TCP0150	150 A AC/DC TekVPI [®] current probe, 20 MHz BW
TCPA300	100 MHz Current Probe, Amplifier (Requires Probe); Recommend using TPA-BNC adapter to provide autoscaling.
TCP312A	DC-100 MHz, AC/DC Current Probe; 30 Amp DC
TRCP0300	30 MHz AC current probe, 250 mA to 300 A
TRCP0600	30 MHz AC current probe, 500 mA to 600 A
TRCP3000	16 MHz AC current probe, 500 mA to 3000 A
TDP0500	500 MHz TekVPI [®] differential voltage probe, ±42 V differential input voltage
TDP1000	1 GHz TekVPI [®] differential voltage probe, ±42 V differential input voltage
TDP1500	1.5 GHz TekVPI [®] differential voltage probe, ±8.5 V differential input voltage
TDP3500	3.5 GHz TekVPI [®] differential voltage probe, ±2 V differential input voltage
TDP4000	4 GHz TekVPI® differential voltage probe, ±2 V differential input voltage
TDP7704	4 GHz TriMode [™] voltage probe
TDP7706	6 GHz TriMode™ voltage probe
TDP7708	8 GHz TriMode™ voltage probe
THDP0100	±6 kV, 100 MHz TekVPI [®] high-voltage differential probe
THDP0200	±1.5 kV, 200 MHz TekVPI [®] high-voltage differential probe
TMDP0200	±750 V, 200 MHz TekVPI [®] high-voltage differential probe
TPR1000	1 GHz, Single-Ended TekVPI [®] Power-Rail Probe; includes one TPR4KIT accessory kit
TPR4000	4 GHz, Single-Ended TekVPI [®] Power-Rail Probe; includes one TPR4KIT accessory kit
TIVH02	Isolated Probe; 200 MHz, ±2500 V, TekVPI, 3 Meter Cable
TIVH02L	Isolated Probe; 200 MHz, ±2500 V, TekVPI, 10 Meter Cable
TIVH05	Isolated Probe; 500 MHz, ±2500 V, TekVPI, 3 Meter Cable
TIVH05L	Isolated Probe; 500 MHz, ±2500 V, TekVPI, 10 Meter Cable
TIVH08	Isolated Probe; 800 MHz, ±2500 V, TekVPI, 3 Meter Cable
TIVH08L	Isolated Probe; 800 MHz, ±2500 V, TekVPI, 10 Meter Cable
TIVM1	Isolated Probe; 1 GHz, ±50 V, TekVPI, 3 Meter Cable
TIVM1L	Isolated Probe; 1 GHz, ±50 V, TekVPI, 10 Meter Cable
TPP0502	500 MHz, 2X TekVPI [®] passive voltage probe, 12.7 pF input capacitance
TPP0850	2.5 kV, 800 MHz, 50X TekVPI® passive high-voltage probe
P6015A	20 kV, 75 MHz high-voltage passive probe
TPA-BNC ¹⁰	TekVPI [®] to TekProbe [™] BNC adapter
103-0503-xx	BNC-to-SMA adapter; rated to 12 GHz

¹⁰ Recommended for connecting your existing TekProbe probes to the 6 Series MSO.

Recommended Probe / Adapter	Description
TEK-DPG	TekVPI deskew pulse generator signal source
067-1686-xx	Power measurement deskew and calibration fixture

Looking for other probes? Check out the probe selector tool at www.tek.com/probes.

Step 10

Add accessories

Add traveling or mounting accessories

Optional Accessory	Description
HC5	Hard carrying case
RM5	Rackmount kit
GPIB to Ethernet adapter	Order model 4865B (GPIB to Ethernet to Instrument Interface) directly from ICS Electronics www.icselect.com/gpib_instrument_intfc.html

Step 11

Select power cord option

Power Cord Option	Description	
A0	North America power plug (115 V, 60 Hz)	
A1	Universal Euro power plug (220 V, 50 Hz)	
A2	United Kingdom power plug (240 V, 50 Hz)	
A3	Australia power plug (240 V, 50 Hz)	
A5	Switzerland power plug (220 V, 50 Hz)	
A6	Japan power plug (100 V, 50/60 Hz)	
A10	China power plug (50 Hz)	
A11	India power plug (50 Hz)	
A12	Brazil power plug (60 Hz)	
A99	No power cord	

Step 12

Add extended service and calibration options

Service Option	Description
Т3	Three Year Total Protection Plan, includes repair or replacement coverage from wear and tear, accidental damage, ESD or EOS.
T5	Five Year Total Protection Plan, includes repair or replacement coverage from wear and tear, accidental damage, ESD or EOS.
R3	Standard Warranty Extended to 3 Years. Covers parts, labor and 2-day shipping within country. Guarantees faster repair time than without coverage. All repairs include calibration and updates. Hassle free - a single call starts the process.
R5	Standard Warranty Extended to 5 Years. Covers parts, labor and 2-day shipping within country. Guarantees faster repair time than without coverage. All repairs include calibration and updates. Hassle free - a single call starts the process.
C3	Calibration service 3 Years. Includes traceable calibration or functional verification where applicable, for recommended calibrations. Coverage includes the initial calibration plus 2 years calibration coverage.
C5	Calibration service 5 Years. Includes traceable calibration or functional verification where applicable, for recommended calibrations. Coverage includes the initial calibration plus 4 years calibration coverage.
D1	Calibration Data Report
D3	Calibration Data Report 3 Years (with Option C3)
D5	Calibration Data Report 5 Years (with Option C5)

Feature upgrades after purchase

Add feature upgrades in the future The 6 Series products offer many ways to easily add functionality after the initial purchase. Node-locked licenses permanently enable optional features on a single product. Floating licenses allow license-enabled options to be easily moved between compatible instruments.

Upgrade feature	Node-locked license upgrade	Floating license upgrade	Description
Add instrument	SUP6-AFG	SUP6-AFG-FL	Add arbitrary function generator
functions	SUP6-RL-1	SUP6-RL-1-FL	Extend record length from 62.5 Mpts to 125 Mpts / channel
	SUP6-RL-2	SUP6-RL-2-FL	Extend record length from 62.5 Mpts to 250 Mpts / channel
	SUP6-RL-3	SUP6-RL-3-FL	Extend record length from 62.5 Mpts to 500 Mpts / channel
	SUP6-RL-4	SUP6-RL-4-FL	Extend record length from 62.5 Mpts to 1 Gpts / channel
	SUP6-RL-1T2	SUP6-RL-1T2-FL	Extend record length from 125 Mpts to 250 Mpts / channel
	SUP6-RL-1T3	SUP6-RL-1T3-FL	Extend record length from 125 Mpts to 500 Mpts / channel
	SUP6-RL-1T4	SUP6-RL-1T4-FL	Extend record length from 125 Mpts to 1 Gpts / channel
	SUP6-RL-2T3	SUP6-RL-2T3-FL	Extend record length from 250 Mpts to 500 Mpts / channel
	SUP6-RL-2T4	SUP6-RL-2T4-FL	Extend record length from 250 Mpts to 1 Gpts / channel
	SUP6-RL-3T4	SUP6-RL-3T4-FL	Extend record length from 500 Mpts to 1 Gpts / channel

Upgrade feature	Node-locked license upgrade	Floating license	Description
Add protocol analysis	SUP6-SRAERO	SUP6-SRAERO-FL	Aerospace serial triggering and analysis (MIL- STD-1553, ARINC 429)
	SUP6-SRAUDIO	SUP6-SRAUDIO-FL	Audio serial triggering and analysis (I ² S, LJ, RJ, TDM)
	SUP6-SRAUTO	SUP6-SRAUTO-FL	Automotive serial triggering and analysis (CAN, CAN FD, LIN, FlexRay, and CAN symbolic decoding)
	SUP6-SRAUTOEN1	SUP6-SRAUTOEN1-FL	100Base-T1 Automotive Ethernet serial analysis
	SUP6-SRAUTOSEN	SUP6-SRAUTOSEN-FL	Automotive sensor serial triggering and analysis (SENT)
	SUP6-SRCOMP	SUP6-SRCOMP-FL	Computer serial triggering and analysis (RS-232/422/485/UART)
	SUP6-SRDPHY	SUP6-SRDPHY-FL	MIPI D-PHY serial analysis (DSI-1, CSI-2)
	SUP6-SREMBD	SUP6-SREMBD-FL	Embedded serial triggering and analysis (I ² C, SPI)
	SUP6-SRENET	SUP6-SRENET-FL	Ethernet serial triggering and analysis (10Base-T, 100Base-TX)
	SUP6-SREUSB2	SUP6-SRESUB2-FL	Embedded USB2 (eUSB2) serial decoding and analysis
	SUP6-SRI3C	SUP6-SRI3C-FL	MIPI I3C serial decoding and analysis
	SUP6-SRMANCH	SUP6-SRMANCH-FL	Manchester serial analysis
	SUP6-SRMDIO	SUP6-SRMDIO-FL	Management Data Input/Output (MDIO) serial decoding and analysis
	SUP6-SR8B10B	SUP6-SR8B10B-FL	8b/10b serial decoding and analysis
	SUP6-SRNRZ	SUP6-SRNRZ-FL	NRZ serial decoding and analysis
	SUP6-SRPM	SUP6-SRPM-FL	Power Management serial triggering and analysis (SPMI)
	SUP6-SRPSI5	SUP6-SRPSI5-FL	PSI5 serial decoding and analysis
	SUP6-SRSPACEWIRE	SUP6-SRSPACEWIRE- FL	Spacewire serial analysis
	SUP6-SRSVID	SUP6-SRSVID-FL	Serial Voltage Identification (SVID) serial decoding and analysis
	SUP6-SRUSB2	SUP6-SRUSB2-FL	USB 2.0 serial bus triggering and analysis (LS, FS, HS)

Upgrade feature	Node-locked license upgrade	Floating license upgrade	Description
Add serial compliance	SUP6-CMAUTOEN	SUP6-CMAUTOEN-FL	Automotive Ethernet automated compliance test solution (100BASE-T1 and 1000BASE-T1)
All serial compliance products require option 6-WIN (SSD with Microsoft Windows 10 operating system)	SUP6-CMAUTOEN10	SUP6-CMAUTOEN10- FL	Automotive Ethernet (10BASE-T1S Short Reach) automated compliance test solution
	SUP6-AUTOEN-BND		Automotive Ethernet compliance, signal separation, PAM3 analysis, 100Base-T1 serial analysis (requires options 6-DJA and 6-WIN)
	SUP6-AUTOEN-SS	SUP6-AUTOEN-SS-FL	Automotive Ethernet signal separation
	SUP6-CMINDUEN10	SUP6-CMINDUEN10-FL	Industrial Ethernet (10Base-T1L Long Reach) automated compliance test solution
	SUP6-CMDPHY	SUP6-CMDPHY-FL	MIPI D-PHY 1.2 automated compliance test solution
	SUP6-CMENET	SUP6-CMENET-FL	Ethernet automated compliance test solution (10BASE-T, 100BASE-T, and 1000BASE-T) Requires SSD with Microsoft Windows 10 operating system
	SUP6-CMNBASET	SUP6-CMNBASET-FL	2.5 and 5 GBASE-T Ethernet automated compliance test (2.5 GHz is recommended)
	SUP6-CMUSB2	SUP6-CMUSB2-FL	USB 2.0 automated compliance test solution
Add advanced analysis	SUP6-DBLVDS	SUP6-DBLVDS-FL	LVDS debug and analysis (requires options 6-DJA and 6-WIN)
	SUP6-DJA	SUP6-DJA-FL	Advanced jitter and eye analysis
	SUP6-DPM	SUP6-DPM-FL	Digital power management
	SUP6-MTM	SUP6-MTM-FL	Mask and Limit testing
	SUP6-PAM3	SUP6-PAM3-FL	PAM3 analysis (requires options 6-DJA and 6- WIN)
	SUP6-PS2	N/A	Power solution bundle (6-PWR, THDP0200, TCP0030A, and 067-1686-XX deskew fixture)
	SUP6-PWR	SUP6-PWR-FL	Advanced power measurements and analysis
	SUP6-SV-BW-1	SUP6-SV-BW-1-FL	Increase Spectrum View capture bandwidth to 2 GHz
	SUP6-SV-RFVT	SUP6-SV-RFVT-FL	Spectrum View RF versus time analysis and trigger
	SUP6-VID	SUP6-VID-FL	NTSC, PAL, and SECAM video triggering
	SUP6B-IMDA	SUP6B-IMDA-FL	Inverter Motor Drive analysis
	SUP6B-IMDA-DQ0	SUP6B-IMDA-DQ0-FL DQ0	Feature for Inverter Motor Drive analysis
Add memory analysis	SUP6-DBDDR3	SUP6-DBDDR3-FL	DDR3 and LPDDR3 debug and analysis
	SUP6-CMDDR3	SUP6-CMDDR3-FL	DDR3 and LPDDR3 automated compliance test solution using TekExpress Automation Platform. Requires options 6-DBDDR3, 6-DJA and SSD with Microsoft WIndows 10 operating system. ≥4 GHz required, 8 GHz recommended for testing of all DDR3 speeds.
Add digital voltmeter	SUP6-DVM	N/A	Add digital voltmeter / trigger frequency counter (Free with product registration at www.tek.com/ register6mso)

Upgrade feature	Upgrade	Description
Add expansion Windows operating system SSD	SUP6B-WIN	Add removable SSD with Windows 10 operating system
Add expansion embedded operating system SSD	SUP6B-LNX	Add removable SSD with embedded operating system

Bandwidth upgrades after purchase

Add bandwidth upgrades in the future

The analog bandwidth of 6 Series products can be upgraded after initial purchase. Bandwidth upgrades are purchased based on the number of FlexChannels, the current bandwidth and the desired bandwidth. All bandwidth upgrades can be performed in the field by installing a software license and a new front panel label.

A calibration data report can also be purchased with the bandwidth upgrade. (Purchase SUP6B-BWx-DATA with option D1, where 'x' is either 4, 6, or 8 depending on the number of FlexChannels on your instrument.)

Oscilloscope model owned	Bandwidth upgrade product	Upgrade option	Upgrade option description
MSO64B	SUP6B-BW4	6B-BW10T25-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 2.5 GHz bandwidth on a (4) FlexChannel model
		6B-BW10T40-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 4 GHz bandwidth on a (4) FlexChannel model
		6B-BW10T60-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 6 GHz bandwidth on a (4) FlexChannel model
		6B-BW10T80-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 8 GHz bandwidth on a (4) FlexChannel model
		6B-BW10T100-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 10 GHz bandwidth on a (4) FlexChannel model
		6B-BW25T40-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 4 GHz bandwidth on a (4) FlexChannel model
		6B-BW25T60-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 6 GHz bandwidth on a (4) FlexChannel model
		6B-BW25T80-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 8 GHz bandwidth on a (4) FlexChannel model
		6B-BW25T100-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 10 GHz bandwidth on a (4) FlexChannel model
		6B-BW40T60-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 6 GHz bandwidth on a (4) FlexChannel model
		6B-BW40T80-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 8 GHz bandwidth on a (4) FlexChannel model
		6B-BW40T100-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 10 GHz bandwidth on a (4) FlexChannel model
		6B-BW60T80-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 6 GHz to 8 GHz bandwidth on a (4) FlexChannel model
		6B-BW60T100-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 6 GHz to 10 GHz bandwidth on a (4) FlexChannel model
		6B-BW80T100-4	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 8 GHz to 10 GHz bandwidth on a (4) FlexChannel model

Oscilloscope model owned	Bandwidth upgrade product	Upgrade option	Upgrade option description
MSO66B S	SUP6B-BW6	6B-BW10T25-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 2.5 GHz bandwidth on a (6) FlexChannel model
		6B-BW10T40-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 4 GHz bandwidth on a (6) FlexChannel model
		6B- BW10T60-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 6 GHz bandwidth on a (6) FlexChannel model
		6B-BW10T80-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 8 GHz bandwidth on a (6) FlexChannel model
		6B-BW10T100-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 10 GHz bandwidth on a (6) FlexChannel model
		6B-BW25T40-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 4 GHz bandwidth on a (6) FlexChannel model
		6B-BW25T60-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 6 GHz bandwidth on a (6) FlexChannel model
		6B-BW25T80-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 8 GHz bandwidth on a (6) FlexChannel model
		6B-BW25T100-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 10 GHz bandwidth on a (6) FlexChannel model
		6B-BW40T60-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 6 GHz bandwidth on a (6) FlexChannel model
		6B-BW40T80-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 8 GHz bandwidth on a (6) FlexChannel model
		6B-BW40T100-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 10 GHz bandwidth on a (6) FlexChannel model
		6B-BW60T80-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 6 GHz to 8 GHz bandwidth on a (6) FlexChannel model
		6B-BW60T100-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 6 GHz to 10 GHz bandwidth on a (6) FlexChannel model
		6B-BW80T100-6	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 8 GHz to 10 GHz bandwidth on a (6) FlexChannel model

Oscilloscope model owned	Bandwidth upgrade product	Upgrade option	Upgrade option description
MSO68B SUP6B-BW	SUP6B-BW8	6B-BW10T25-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 2.5 GHz bandwidth on a (8) FlexChannel model
		6B-BW10T40-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 4 GHz bandwidth on a (8) FlexChannel model
		6B-BW10T60-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 6 GHz bandwidth on a (8) FlexChannel model
		6B-BW10T80-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 8 GHz bandwidth on a (8) FlexChannel model
		6B-BW10T100-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 1 GHz to 10 GHz bandwidth on a (8) FlexChannel model
		6B-BW25T40-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 4 GHz bandwidth on a (8) FlexChannel model
		6B-BW25T60-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 6 GHz bandwidth on a (8) FlexChannel model
		6B-BW25T80-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 8 GHz bandwidth on a (8) FlexChannel model
		6B-BW25T100-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 2.5 GHz to 10 GHz bandwidth on a (8) FlexChannel model
		6B-BW40T60-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 6 GHz bandwidth on a (8) FlexChannel model
		6B-BW40T80-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 8 GHz bandwidth on a (8) FlexChannel model
	6B-BW40T100-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 4 GHz to 10 GHz bandwidth on a (8) FlexChannel model	
		6B-BW60T80-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 6 GHz to 8 GHz bandwidth on a (8) FlexChannel model
		6B-BW60T100-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 6 GHz to 10 GHz bandwidth on a (8) FlexChannel model
		6B-BW80T100-8	License; Bandwidth upgrade for 6 Series B MSO; Upgrade from 8 GHz to 10 GHz bandwidth on a (8) FlexChannel model

Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.

Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

Product Area Assessed: The planning, design/development and manufacture of electronic Test and Measurement instruments.

6 Series B MSO

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* European toll-free number. If not accessible, call: +41 52 675 3777

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